

Active Device Characterization At Millimeter Wave Frequencies



Suren Singh
Lead Application Engineer Millimeter and THz
Solutions
Agilent Technologies



Agilent Technologies

Agenda

- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- Q&A

Millimeter Wave Frequency Band Applications

Millimeter Wave Component Test

- On Wafer Device Characterization
- Wireless HDMI & WiGiG (E-Band)
- Automotive Radar Components (E& W-Band)

Antenna

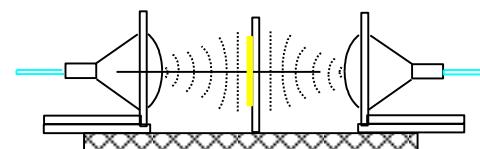
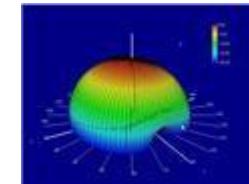
- Integrated on-wafer antenna arrays
- (Sub) mm-wave interferometer for astrophysics (Emerging)
- Atacama Large Millimeter Array (ALMA) (NRAO, ESO, IRAM)
- Deep Space Radio Telescopes

Materials and Imaging

- Free space material measurements.
- Security Imaging Systems
- Corrosion Detection
- Bio-fuel (Emerging)

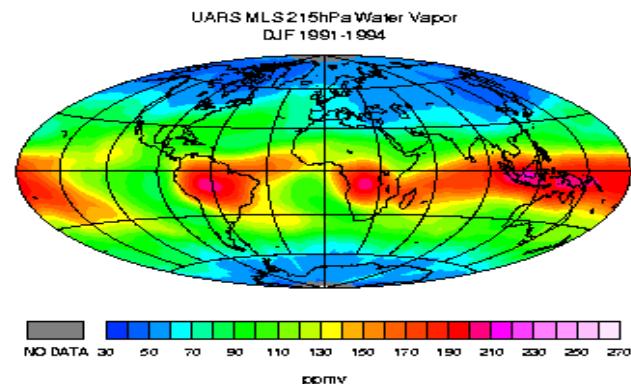
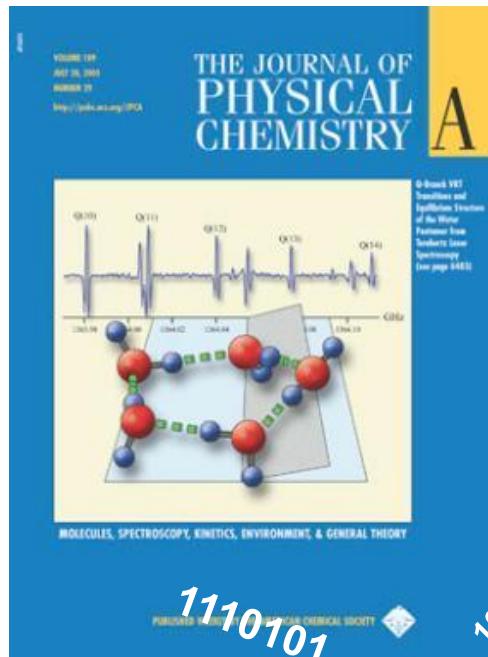


HD Disc Player



THz Frequency Applications

- Radio Astronomy
- Atmospheric Studies
- Chemical / Molecular Spectroscopy
- Plasma and Accelerator Diagnostics
- Biological Imaging
- Materials Characterization
- General Test and Measurement



Agenda

- **Millimeter wave and THz applications**
- **Measurement Solution**
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- **Active Device Measurements**
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- **Q&A**

Measurement Driven Architecture

Millimeter wave Devices

- Passive Devices
- Amplifiers
- Mixers
- Semiconductors
- Antennas
- Materials



Millimeter wave Measurements

- S-Parameters (N-port, Differential)
- Absolute power
- Gain compression
- Pulsed measurements
- Material parameters
- Time domain

Measurement Driven Architecture

Millimeter wave Measurements

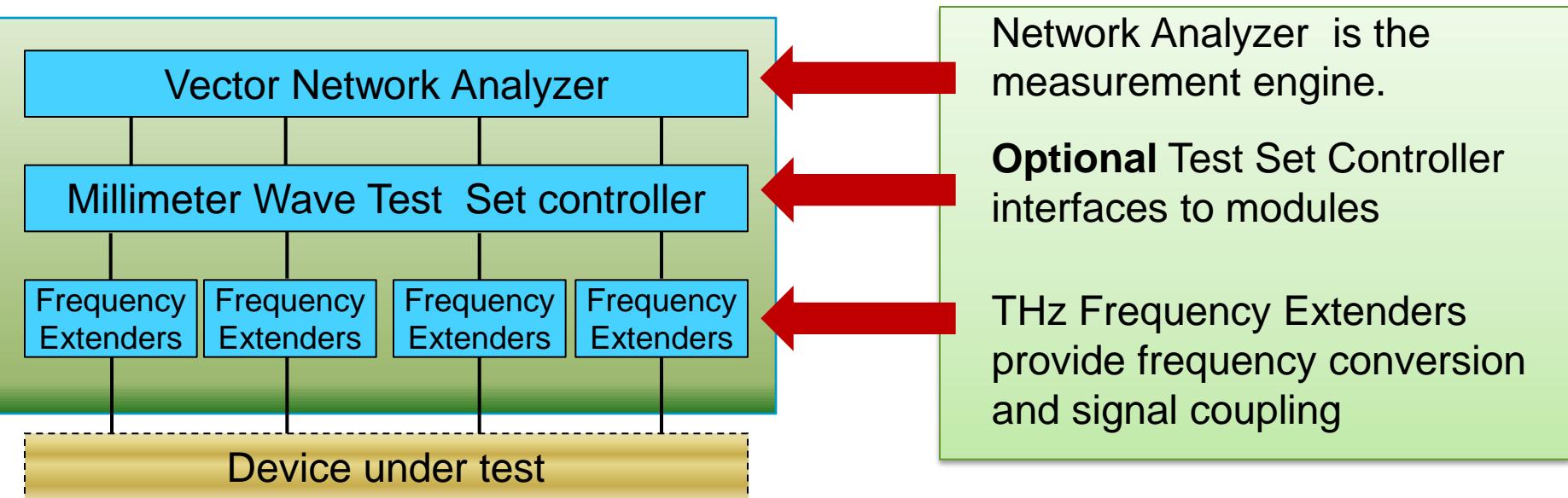
- S-Parameters (N-port, Differential, Translated)
- Absolute power
- Gain compression
- Pulsed measurements
- Material parameters
- Time domain



Millimeter wave Features

- Calibration: S-Parameters & Power
- Bias Tee
- Differential Source
- Remote Modules
- Measure & level power
- Pulse drive and measure
- Measure mixers
- Measure multi-ports
- Wide dynamic range
- Measure multiple bands
- Probing

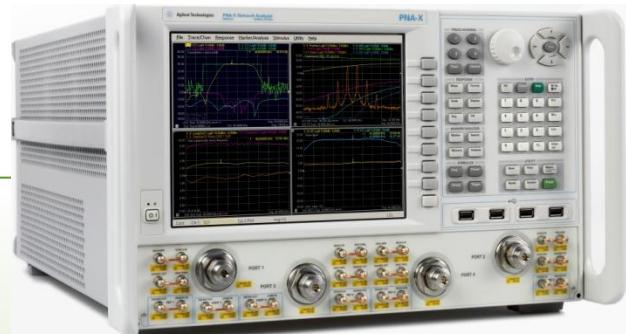
Solution Architecture



PNA / PNA-X Network Analyzer

Key Enabling Features:

- 26.5 /43.5/50/67GHz versions
- Configurable Test set options
- Rear panel RF / LO Output
- Rear panel direct IF Access
- Test set controller interface
- Frequency Offset Capability
- Dual, spectrally pure sources with low phase noise
- Integrated pulse measurements
- Source Power Calibration & Receiver power leveling
- Broadband match corrected power Calibration



N5247A 4-Port PNA-X



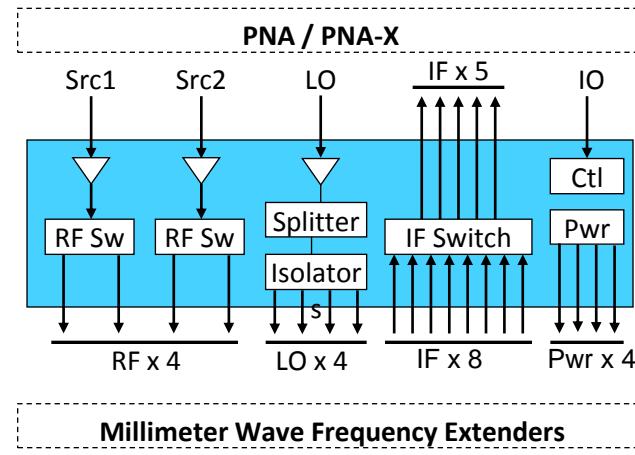
Agilent Technologies

Millimeter Wave Test Set Controller

- Provides LO & RF distribution to modules
- Provides DC power to modules
- 2-port (N5261A) and 4-port (N5262A) versions
- Flexible setup: measure multiple bands
- Mixer Measurements without external Sources
- Easily switch between PNA/PNA-X and mm-wave mode



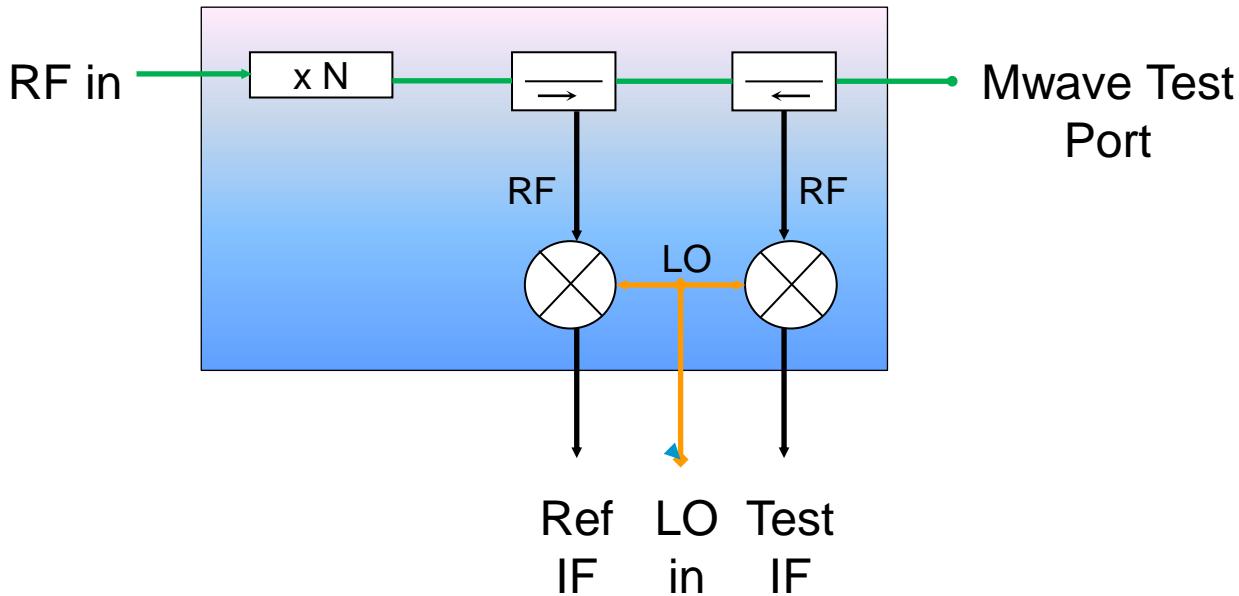
Four Port N5262 A Test Set Controller



Agilent Technologies

Millimeter Frequency Extenders

- Broadband Extenders: 10M-110GHz
- Banded Extenders: 50 GHz ... 1 THz



Banded Frequency Extenders

WR 15	50 – 75 GHz
WR 12	60 – 90 GHz
WR 12E	54 – 92 GHz
WR 10	75 – 110 GHz
WR 6	110 – 170 GHz
WR 5	140 – 220 GHz
WR 3	220 – 325 GHz
WR 2.2	325 – 500 GHz
WR 1.5	500 – 750 GHz
WR 1.0	750 – 1.1 THz



Agilent Technologies

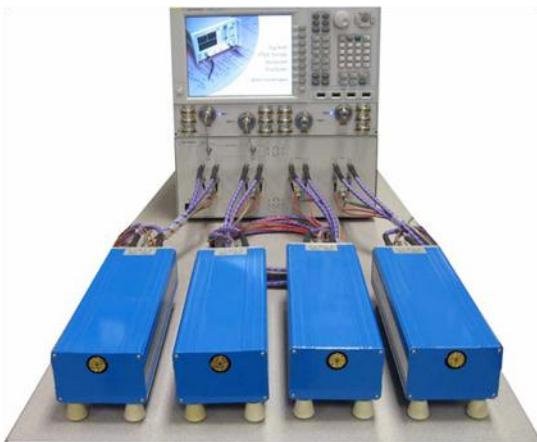
MHz to 110 GHz Broadband Solution

- Single-sweep over 10MHz-110GHz
- 2-port & 4-port options
- Based on N5247A 67 GHz PNA
- 1.0 mm Test Port
- Key Features:
 - Built in Kelvin Bias Tees
 - Power leveling
 - Settable Power to -50 dBm
 - True differential drive
 - Pulse measurements
 - Mixer measurements



Agilent Technologies

Banded Waveguide solutions to 1.1 THz



PNA / PNA-X Banded Waveguide
Solution With Test Set Controller



Banded Waveguide solution Without
Test Controller



Banded Waveguide solution With
Proprietary Test Controller

Agenda

- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- Q&A

Broadband Amplifier Measurement Application

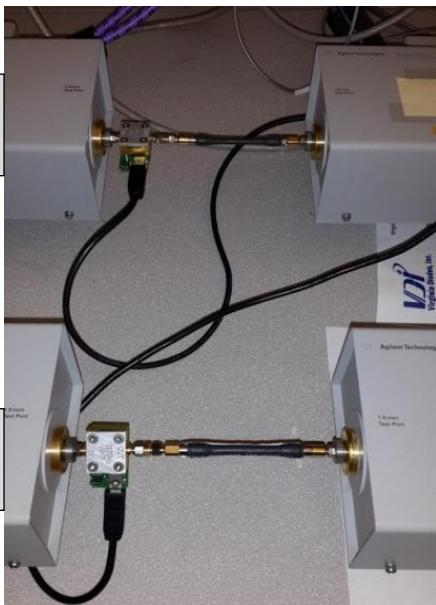


Port 3

Port 4

Port 1

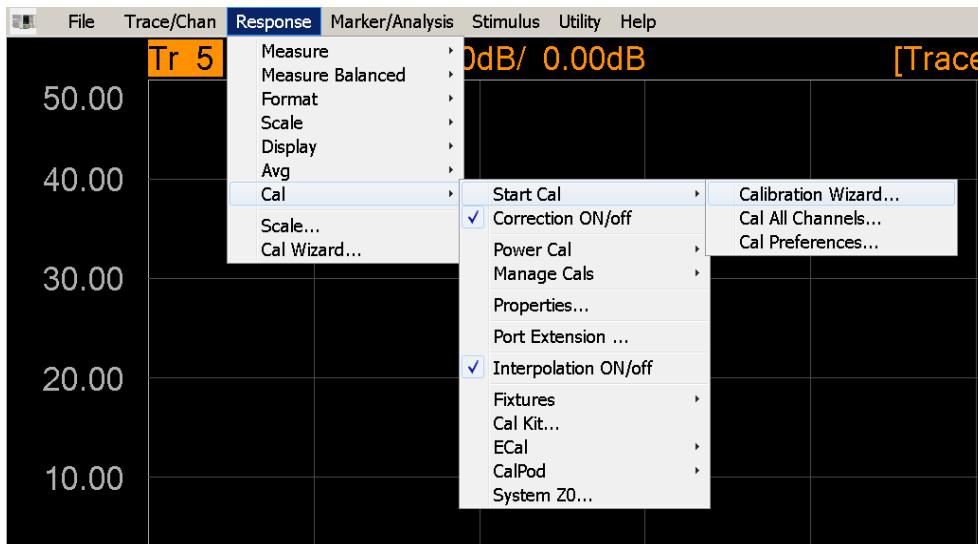
Port 2



Measurement Requirements

- Single Connection Measurement
- Input match
- Output match
- Amplifier gain
- Amplifier compression
- Amplifier pulsed response
- 4 Port True Differential

4- Port Match corrected Source power Calibration



Calibration Wizard: Begin Calibration

SmartCal (GUIDED Calibration)

UNGUIDED Calibration (Response, 1-port, 2-port): Use Mechanical Standards

Use Electronic Calibration (ECal)

Select calibration preference.
Not sure about preferences?
Assistance is available in the online Help.

Save this choice and don't show this page next time.

[Back](#) [Next >](#) [Cancel](#) [Help](#)

Select Ports for Guided Calibration

Cal Type Selection: 4 Port Cal

Selected 1st Port:	1
Selected 2nd Port:	2
Selected 3rd Port:	3
Selected 4th Port:	4

Calibrate source and receiver power

[Back](#) [Next >](#) [Cancel](#) [Help](#)

Guided Calibration: Select DUT Connectors and Cal Kits

DUT Connectors: Port 1: 1.8mm female, Port 2: 1.8mm male, Port 3: 1.8mm female, Port 4: 1.8mm male

Cal Kits: 85059A Database

Cal Method: 4-Port

Modify Cal: Change Cal Method, standards.

[Back](#) [Next >](#) [Cancel](#) [Help](#)

Power Cal Settings

Power cal at: Port 1 Use Multiple Sensors [Sensor Settings...](#)

Sensor	Start	Stop	Adapter	Connector	Cal Kit
50 GHz Sensc	10.000000 MHz	50.000000 GHz	<input type="checkbox"/>	Use Ignored	Remove
V-Band Sensc	50.000000 GHz	75.000000 GHz	<input type="checkbox"/>	Use Ignored	Remove
W-Band Sensc	75.000000 GHz	110.000000 GHz	<input type="checkbox"/>	Use Ignored	Remove

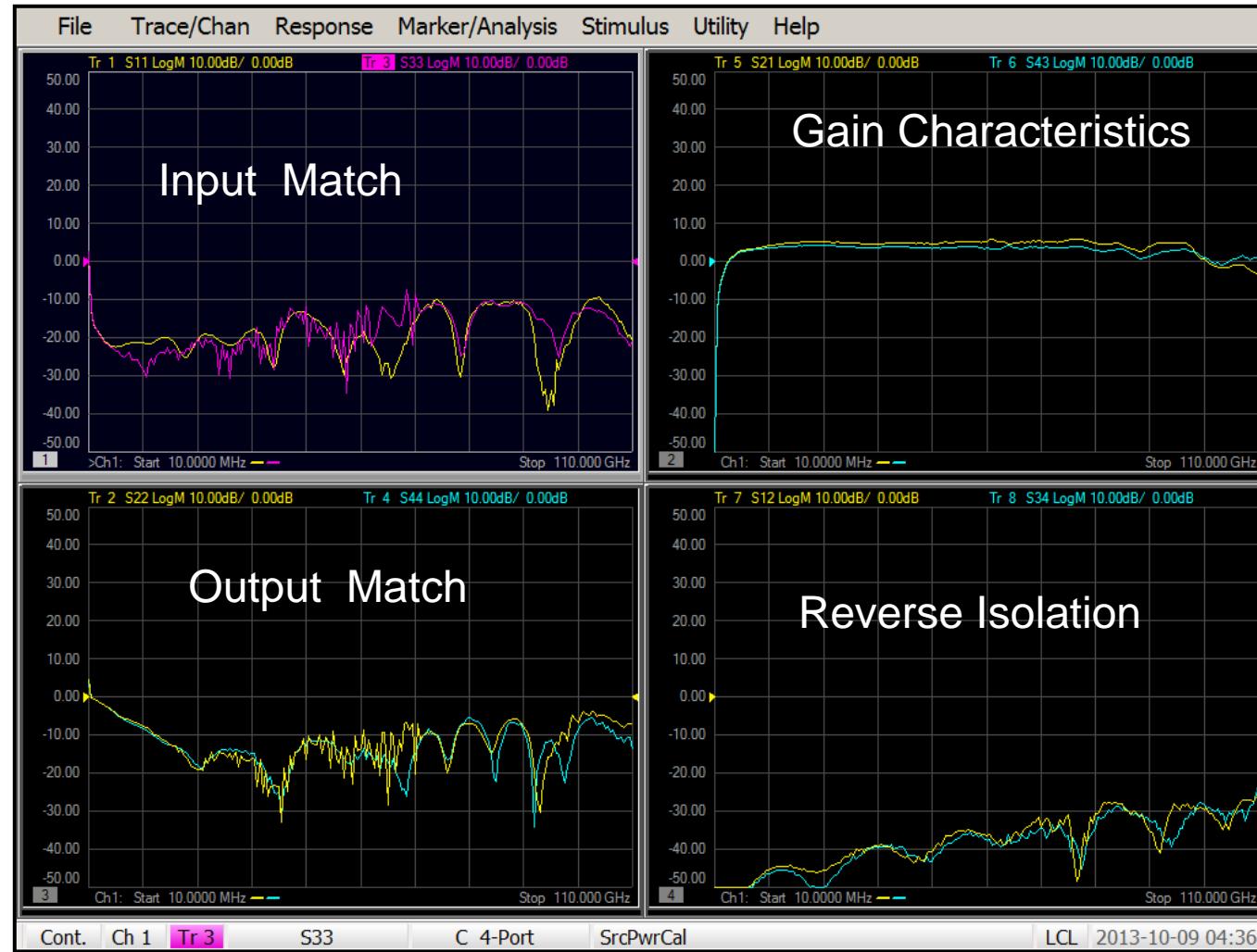
Accuracy: Add Sensor Tolerance: 0.250 dBm Max Number of Readings: 13

[Back](#) [Next >](#) [Cancel](#) [Help](#)



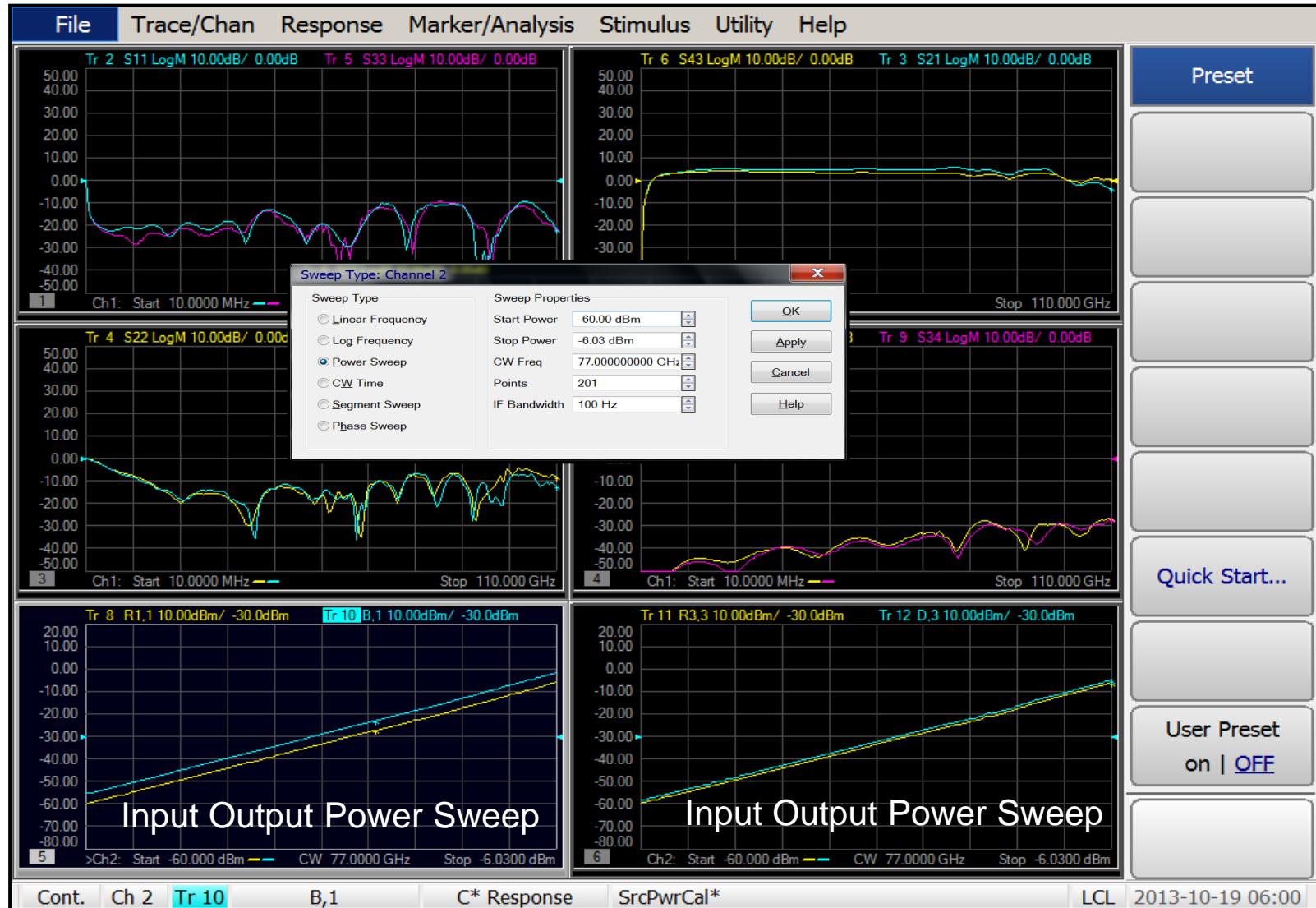
Agilent Technologies

Broadband Amplifier Match and Gain Results



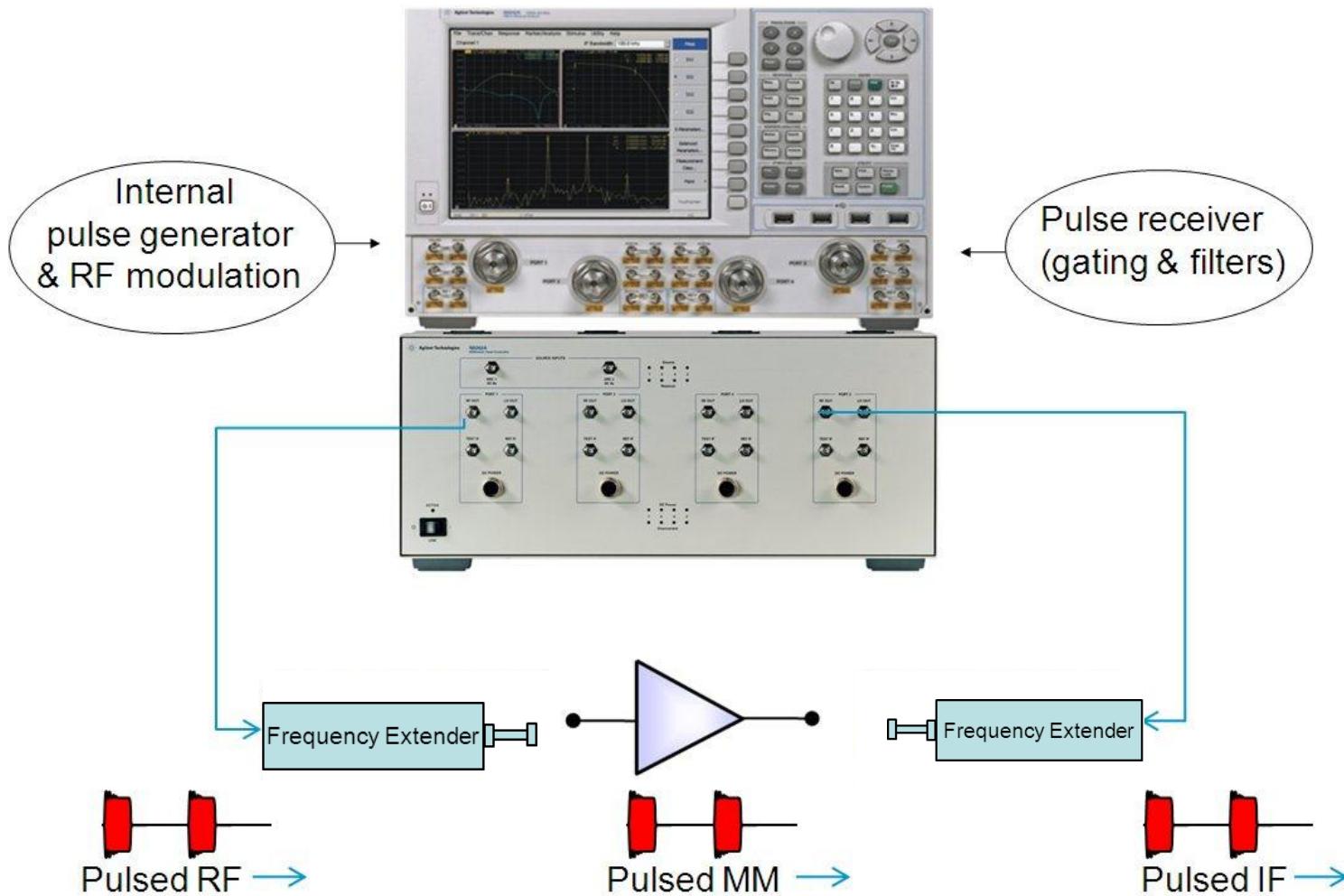
Agilent Technologies

Broadband Amplifier Adding Power Sweep



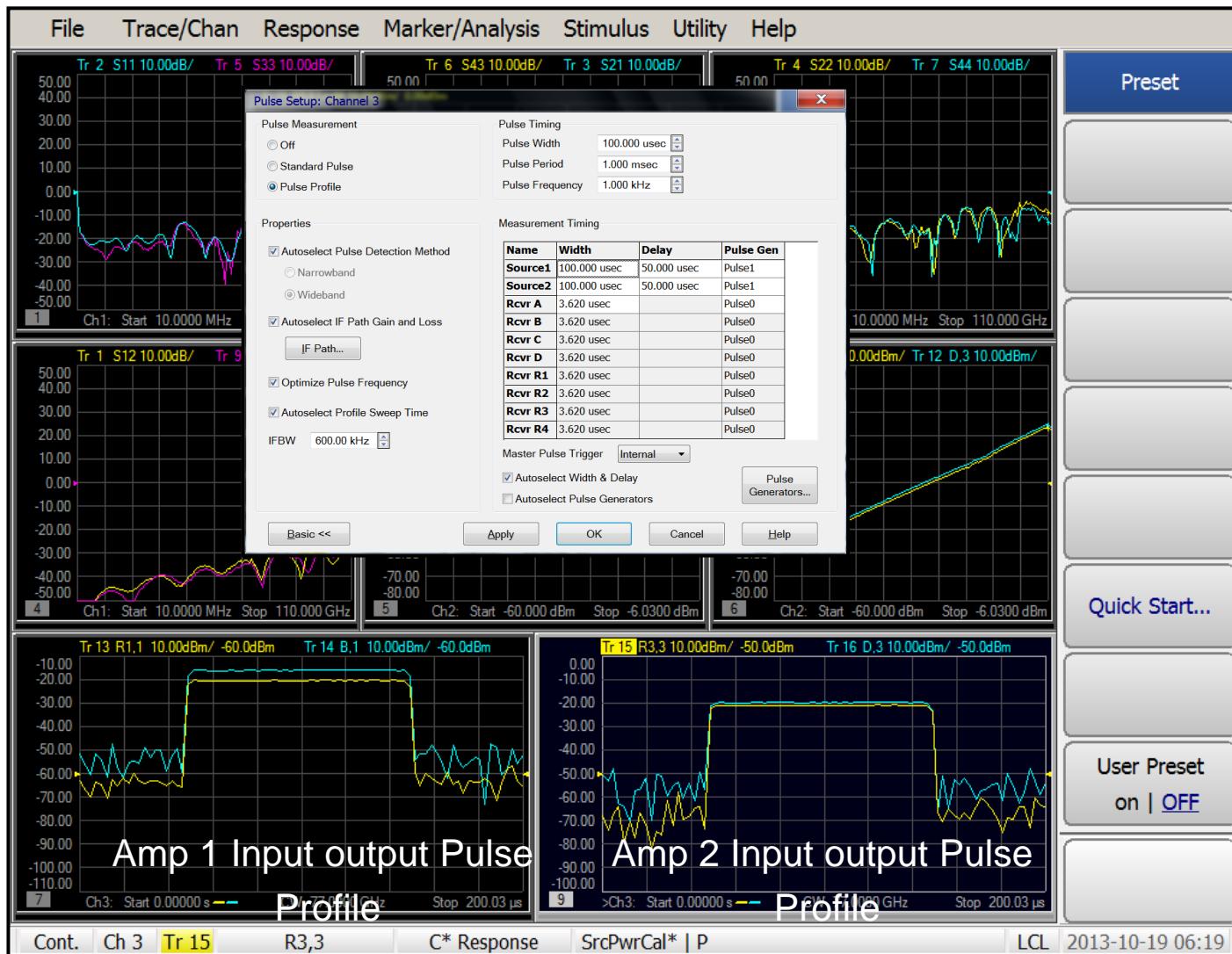
Agilent Technologies

Broadband Amplifier Adding Pulsed Response



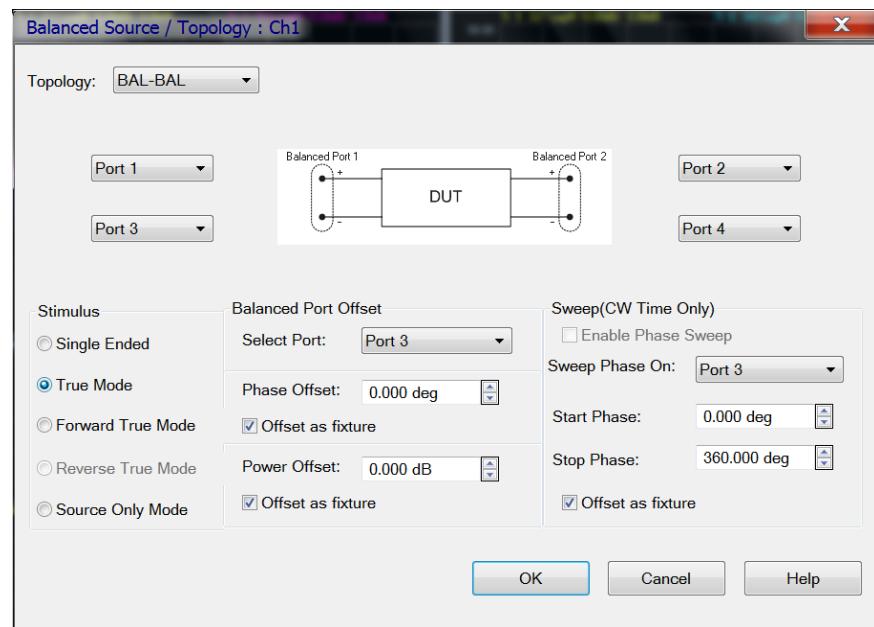
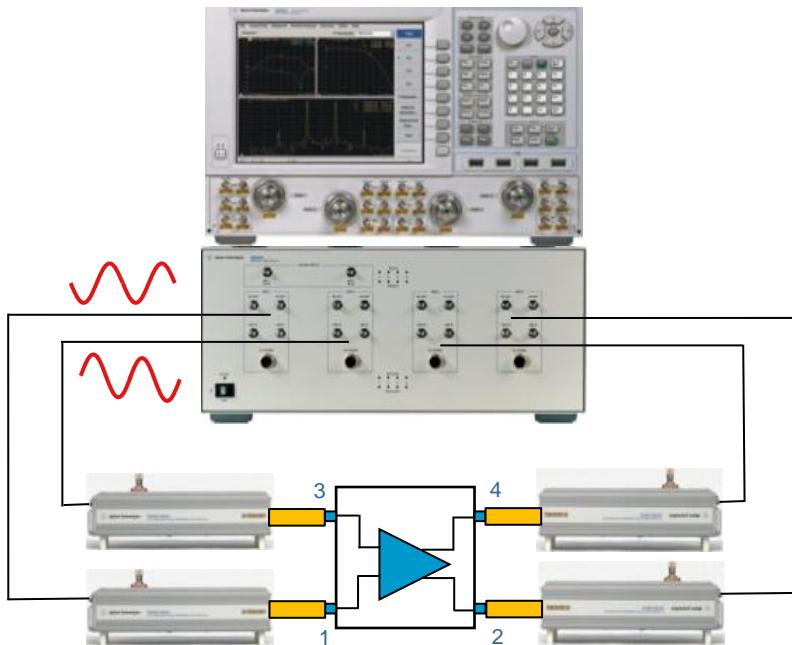
Agilent Technologies

Broadband Amplifier Adding Pulsed Response



Agilent Technologies

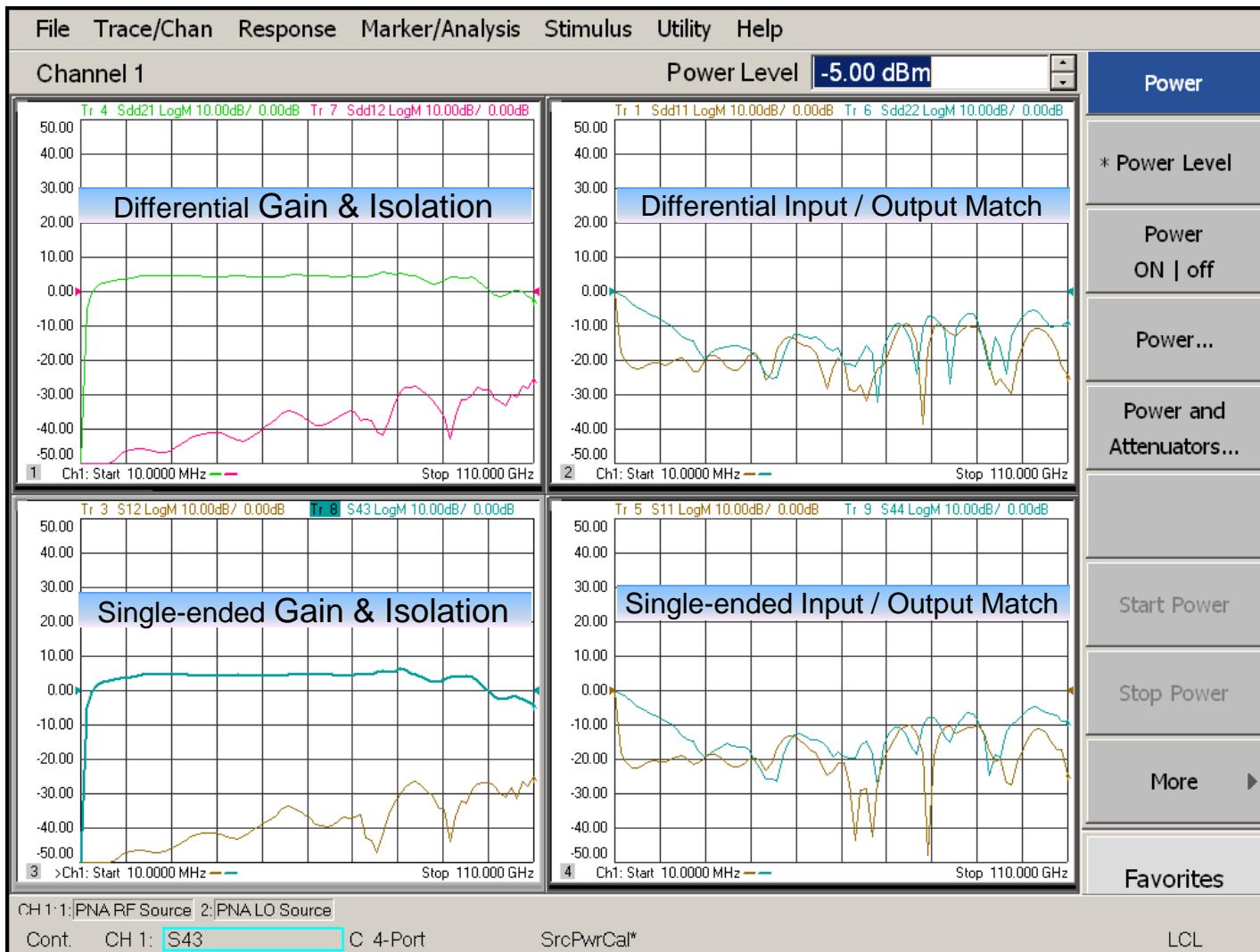
Broadband Amplifier Adding True Mode Measurements



Integrated True-mode Stimulus Application: iTMSA (Option 460)

- Applies DUT/VNA mismatch-corrected true-differential or true-common-mode stimulus in forward, reverse or both directions.
- Precisely control amplitude and phase offsets.
- Make fully-error-corrected balanced measurements on balanced-input and balanced-output as well as one port single-ended and one port balanced devices.

Broadband Amplifier Adding True Mode Measurements

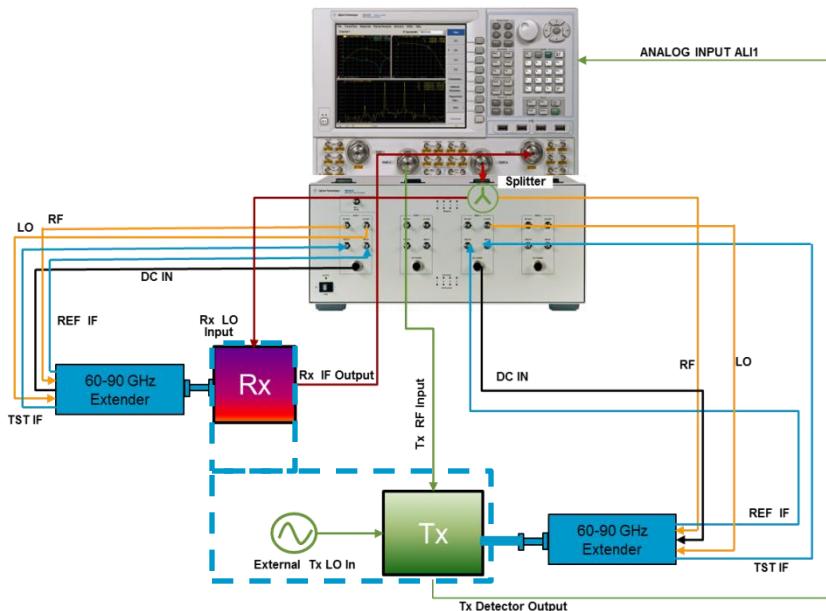


Agilent Technologies

Agenda

- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - **SCMM of 60 GHz Tx / Rx components**
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- Q&A

SCMM of 60 GHz Tx/Rx Components



Measurement Requirements

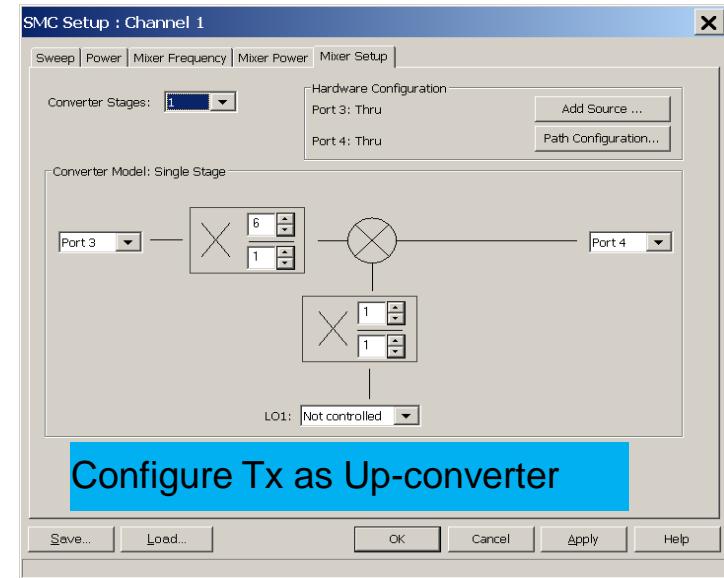
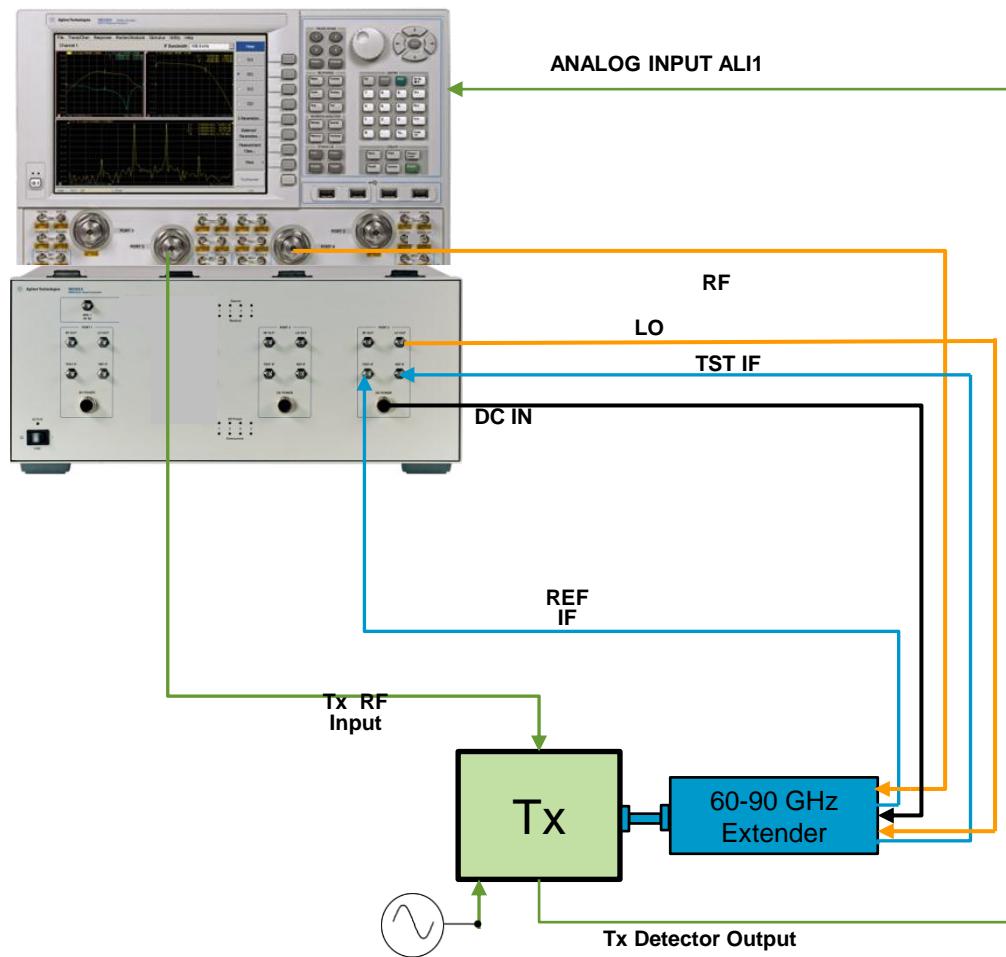
- Conversion and S-Parameters of Tx
- Spectrum of Tx output with RF applied
- Spectrum measurement of Tx output for LO Leakage
- Tx Detector versus Output power
- Tx Detector vs. Input Power Sweep
- Rx Conversion and S-Parameters
- Rx Power Sweep of input Power
- Rx Swept LO Response
- Rx Noise Figure measurement



Agilent Technologies

Agilent Confidential

Tx Measurement Configuration Using SMC



Agilent Technologies

Agilent Confidential

Tx Measurement Configuration - Calibration

The image displays six windows from an Agilent measurement software interface, illustrating the process of configuring Tx measurement calibration:

- SMC Calibration Setup**: A dialog for setting up calibration. It includes options for "Waveguide/In-Fixture/On-Wafer Setup" (unchecked), "Independent power cal for input and output ports. (no thru)" (checked), "Enable Phase Correction" (unchecked), and "Additional Power Cal Steps". Under "Phase Correction", there are three radio buttons: "Use Known Mixer Delay" (selected), "0.000000 ps", "Use Characterized Mixer", and "Use Phase Reference Calset". Buttons for "Enable LO1 Power Cal" and "Enable LO2 Power Cal" are also present. Navigation buttons: Back, Next, Cancel, Help.
- SMC Calibration: Select DUT Connectors and Cal Kits**: A dialog for selecting DUT connectors and calibration kits. It shows "DUT Connectors" and "Cal Kits" for Port 3 and Port 4. Port 3 has "APC 3.5 male" selected. Port 4 has "W-Band waveguide" selected. Cal Kits listed are "N4691-60004 ECal 01076" and "W11844A". A note says "Modify Cal: Change Cal Method, standards." Navigation buttons: Back, Next, Cancel, Help.
- Power Cal Settings for Port 4**: A dialog for power calibration settings. It shows "Power cal at Port 4". Options include "De-embed adapter" (unchecked), "Power Sensor Connector" (Ignored), "Cal Kit" (dropdown menu), "Use Power Table" (unchecked), and "Power Table..." button. "Accuracy Tolerance" is set to "0.250 dBm" and "Max Number of Readings" is set to "13". Navigation buttons: Back, Next, Cancel, Help.
- Power Meter Settings**: A dialog for power meter settings. It shows "Interface" (radio buttons for GPIB Address 14, USB, LAN, Any), "Sensors" (dropdown menu), "Setting" (Tolerance "0.050 dBm", Max Number of Readings "3"), and "Sensor Loss Compensation" (checkbox "Use Loss Table", "Edit Table" button). Navigation buttons: OK, Cancel, Help.
- Power Sensor Settings**: A dialog for power sensor settings. It shows "Sensor A" (Reference Cal Factor "100.0 %") and "Sensor B" (Reference Cal Factor "100.0 %"). Both sections have tables for Frequency and Cal Factor. "Sensor A" table data:

FREQUENCY	CAL FACTOR
75.000000 Hz	86.7 %
77.000000 Hz	85.6 %
79.000000 Hz	92.7 %
81.000000 Hz	98.0 %

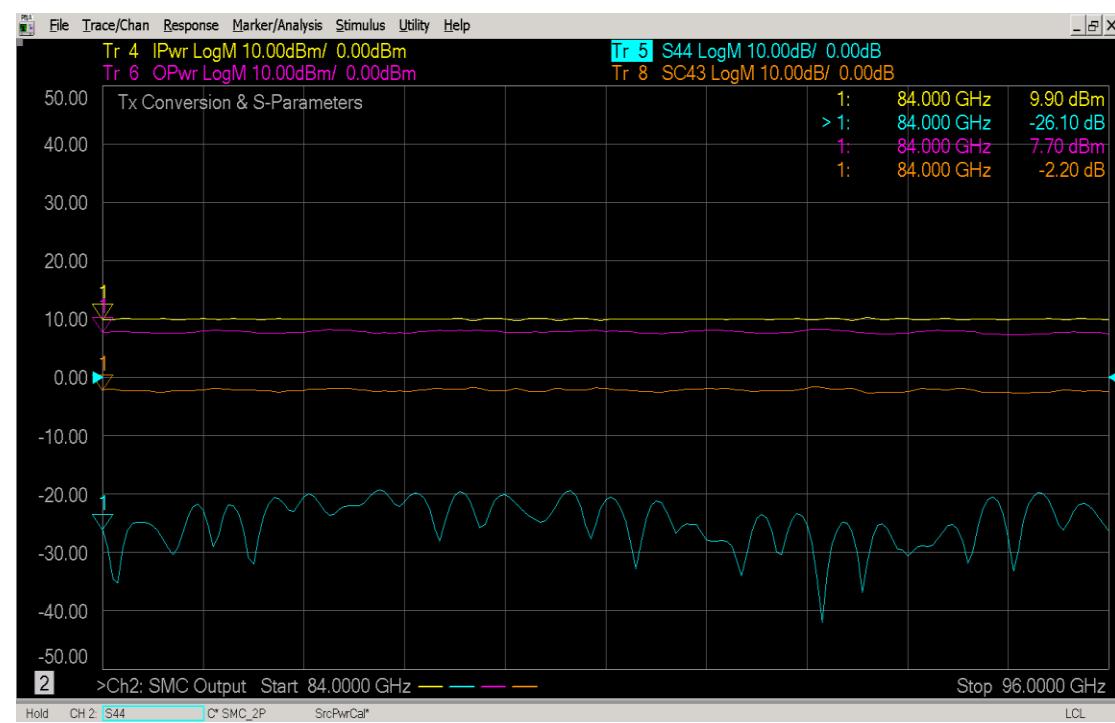
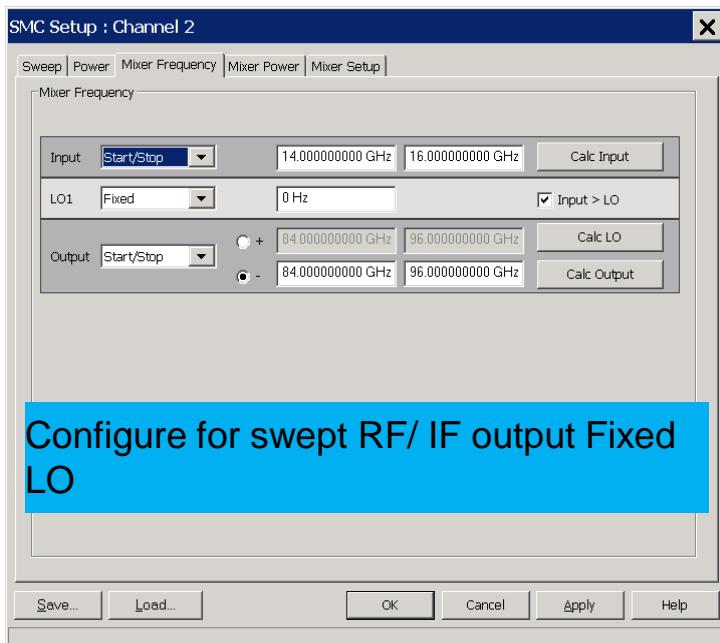
"Sensor B" table data:

FREQUENCY	CAL FACTOR
10.000000 MHz	
11.000000 GHz	

Buttons include "Delete Cal Factor", "Delete All", "Load Cal Factors...", "Save Cal Factors...", "Use this sensor only (no frequency checking)", "Minimum Frequency" (75.000000 GHz), "Maximum Frequency" (110.000000 GHz), "Internal Zero" (radio button), "External Zero" (radio button), "Zero", and "Calibrate". Navigation buttons: OK, Cancel, Help.
- Save As User Calset**: A dialog for saving a user calibration set. It shows "Existing calsets" (list: 1.0mm cal, CalSet_1, CalSet_10, CalSet_10_Port_1, CalSet_10_Port_1_1, CalSet_10_Port_3, CalSet_11, CalSet_12, CalSet_13, CalSet_14, CalSet_15) and "Select calset from list or type new name below:". The input field contains "TX_Cal". Buttons: "Edit Name", "Save", "Cancel", "Help".

Using SMC Calibration allows for independent calibration of each port.

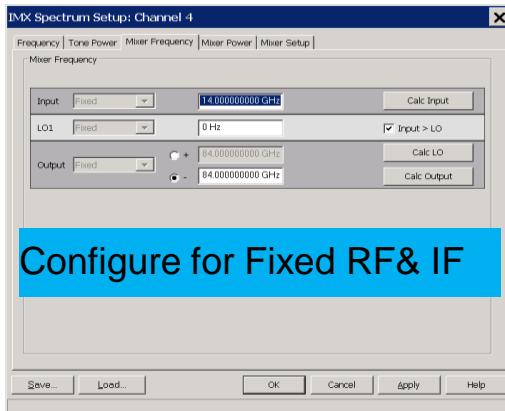
Adding Conversion and S-Parameters of Tx



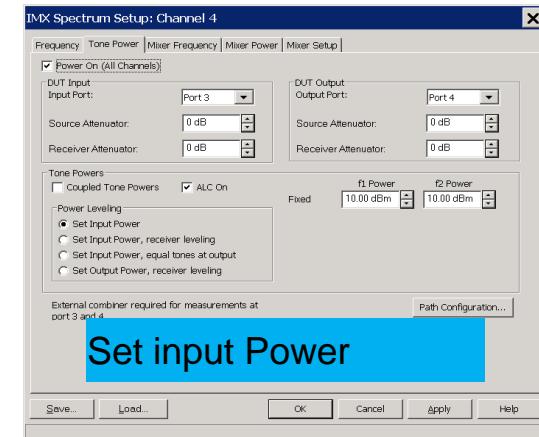
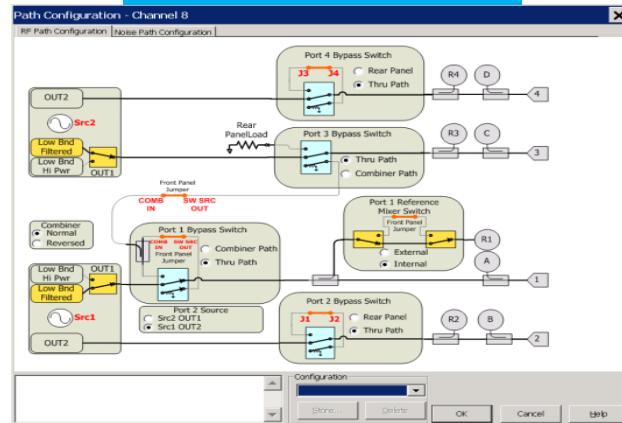
Agilent Technologies

Adding Spectrum of Tx output with RF applied Using IMDx

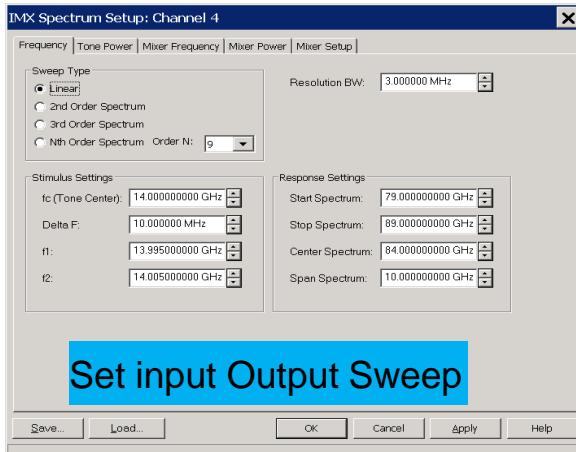
Configure Signal Path



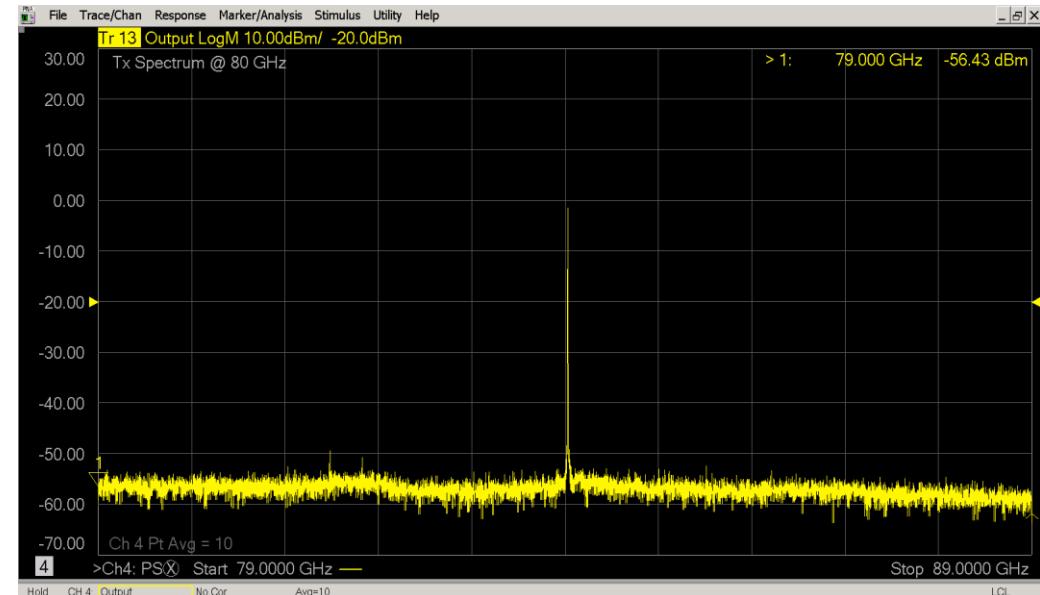
Configure for Fixed RF& IF



Set input Power

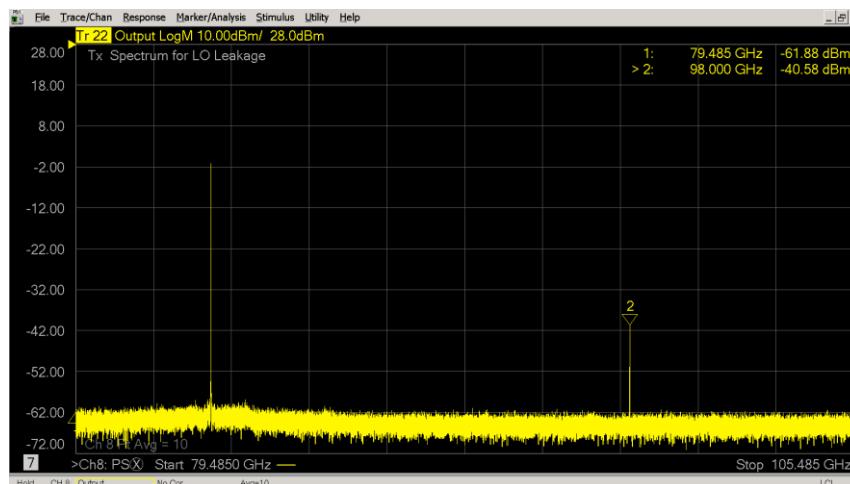
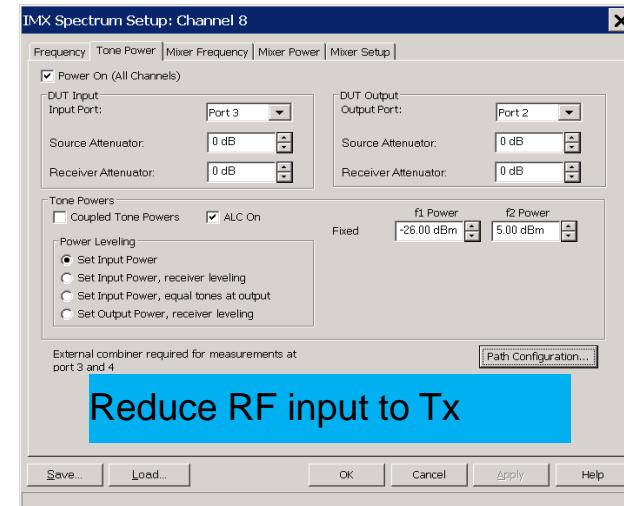
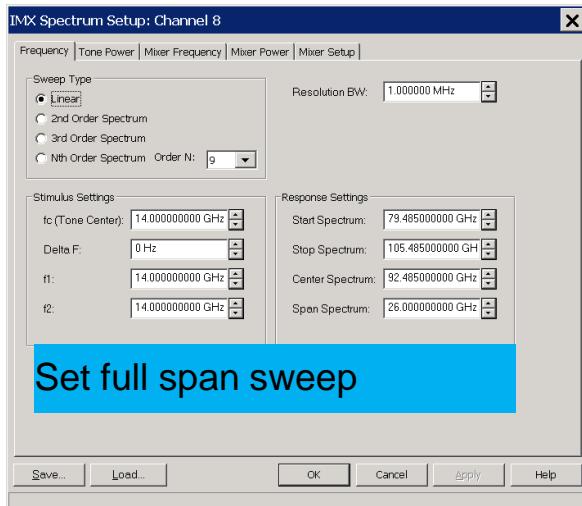


Set input Output Sweep



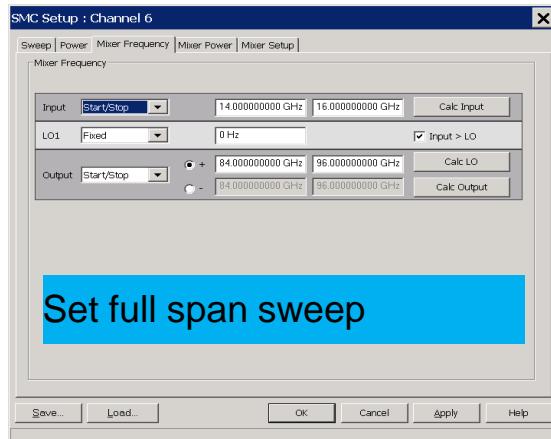
Agilent Technologies

Adding Spectrum measurement of Tx output for LO Leakage – Uses IMDx



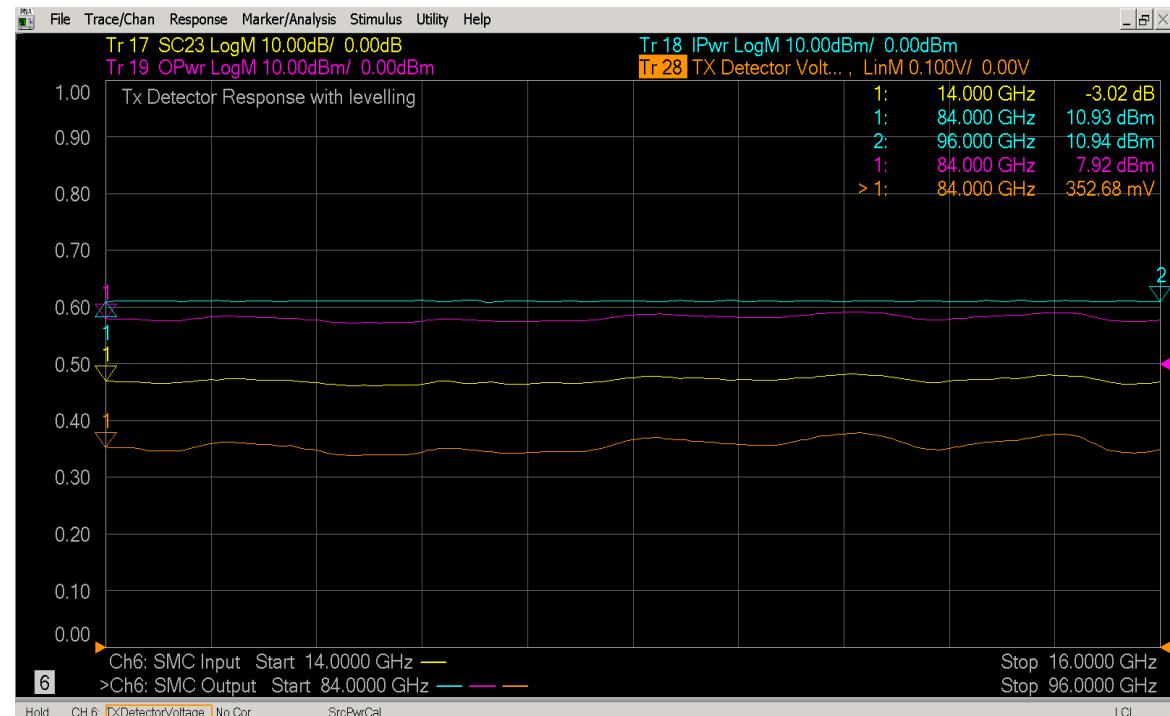
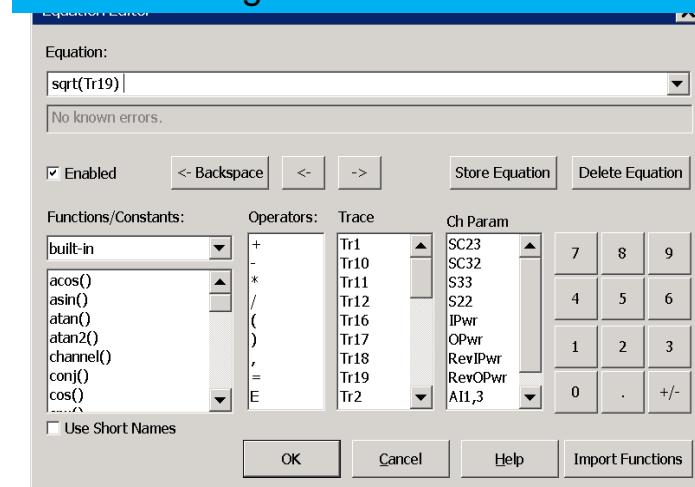
Agilent Technologies

Adding Tx Detector versus Output power - Simulated



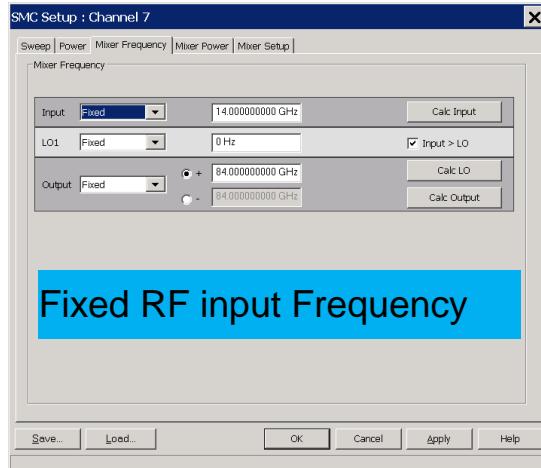
Set full span sweep

Use Equation Editor to simulates
Detector voltage

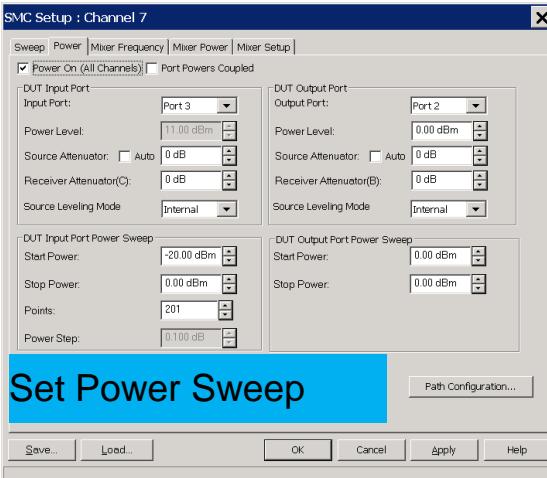


Agilent Technologies

Adding Tx Detector vs. Input Power Sweep - Simulated



Fixed RF input Frequency

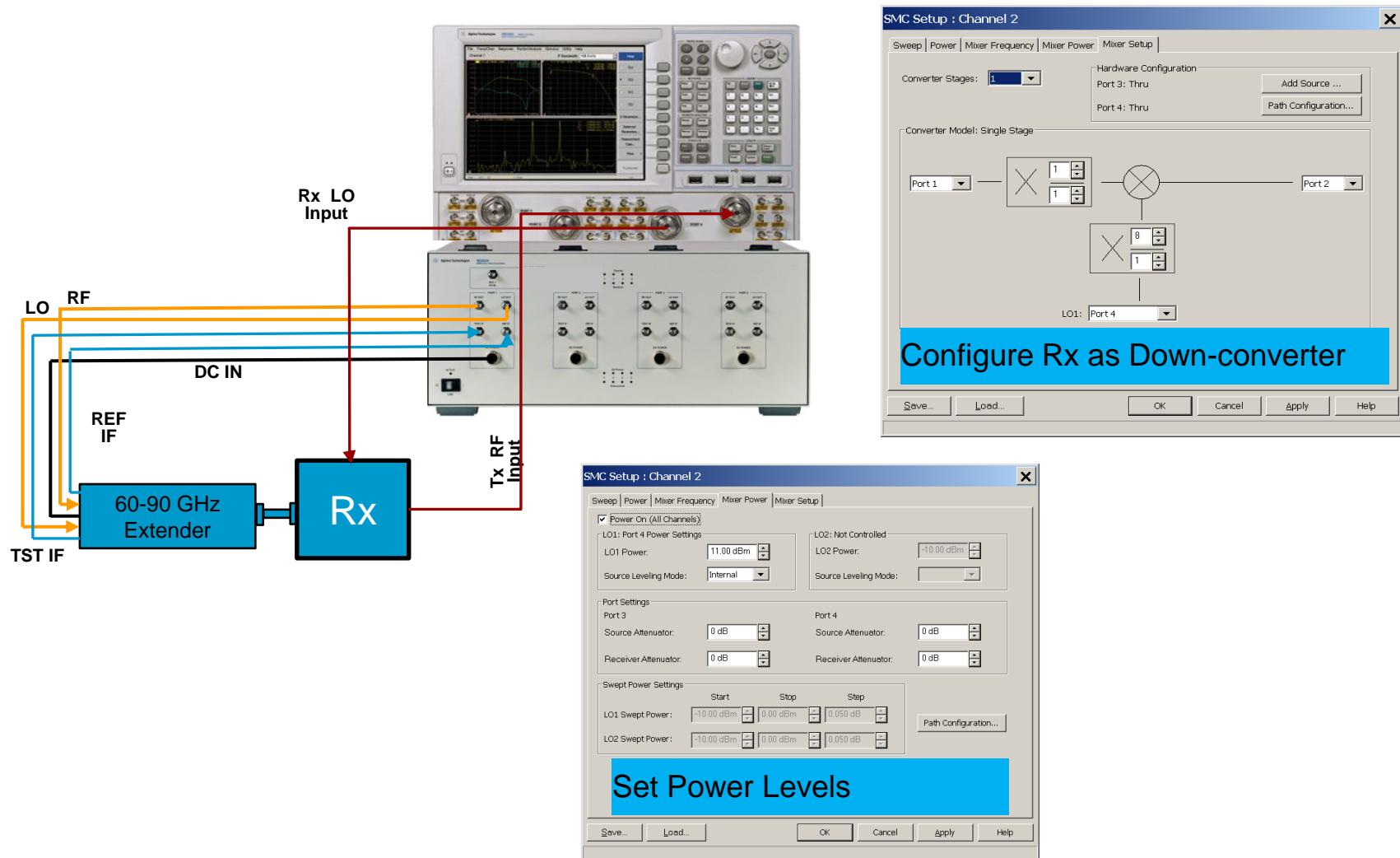


Set Power Sweep



Agilent Technologies

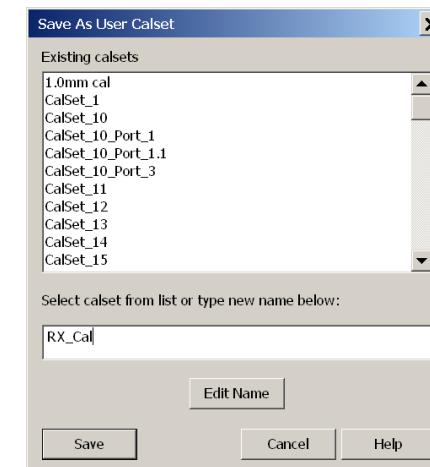
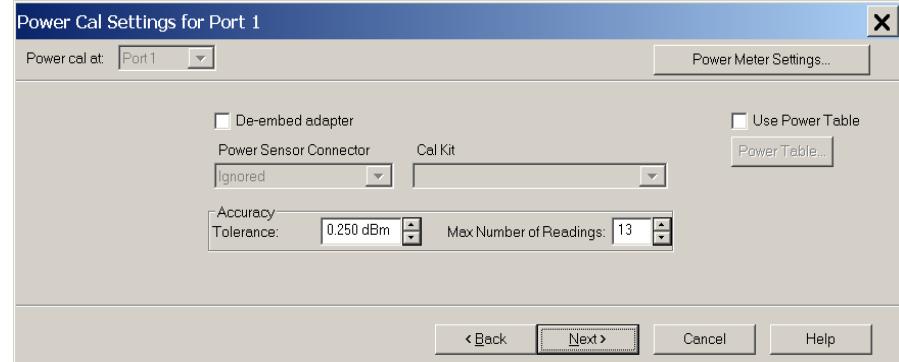
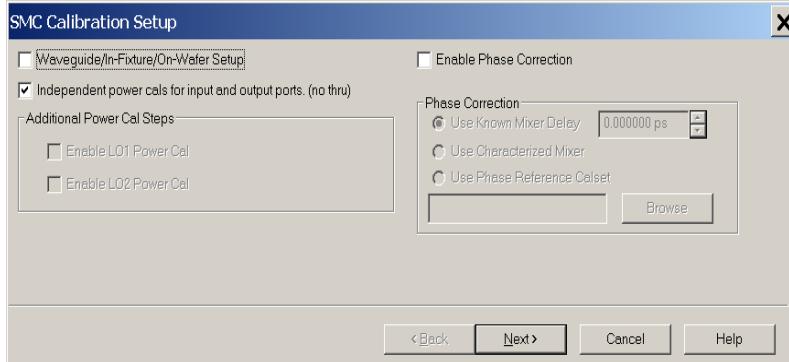
Rx Measurement Configuration Using SMC



Agilent Technologies

Agilent Confidential

Rx Measurement Configuration - Calibration

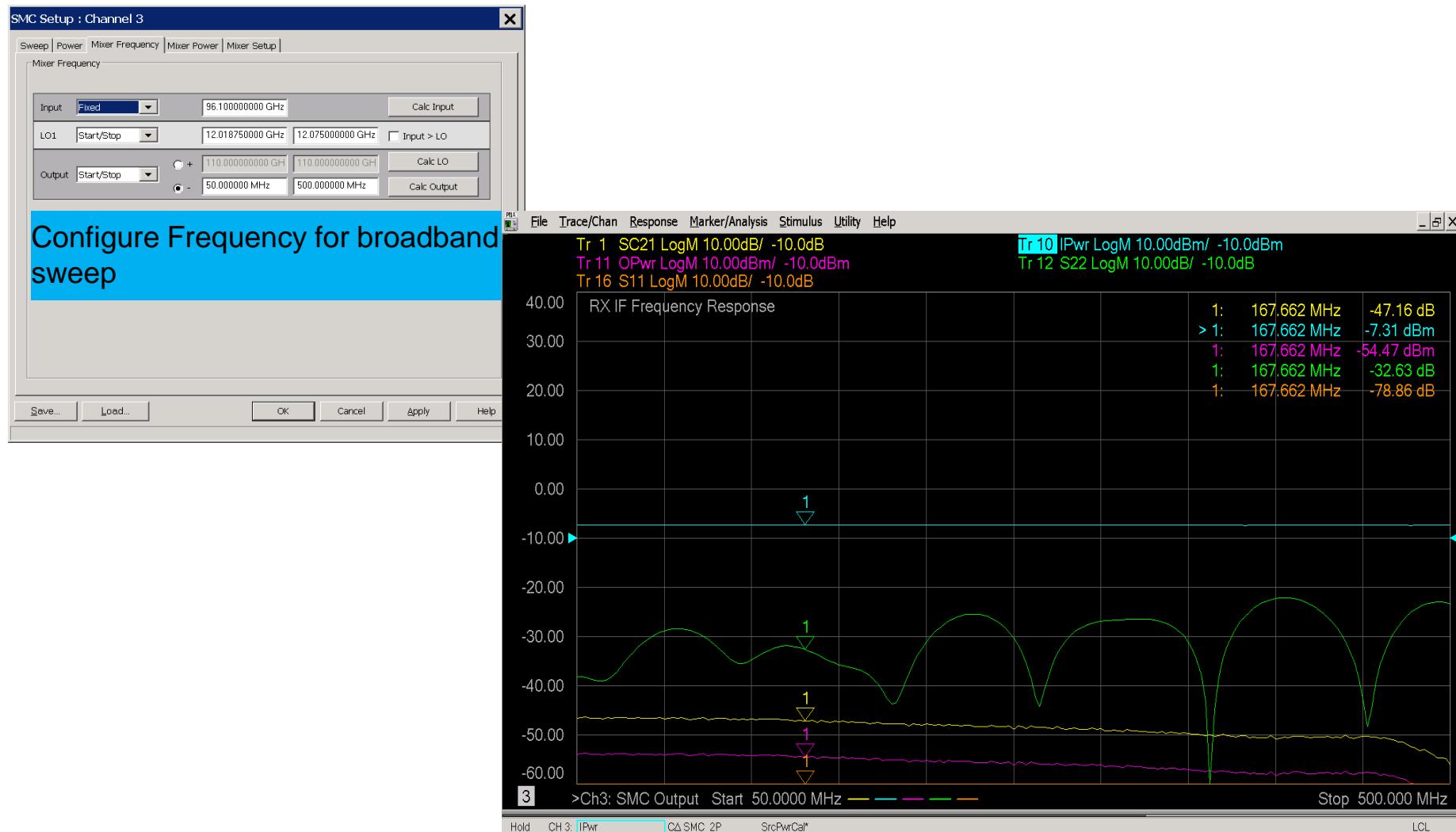


Using SMC Calibration allows for independent calibration of each port.

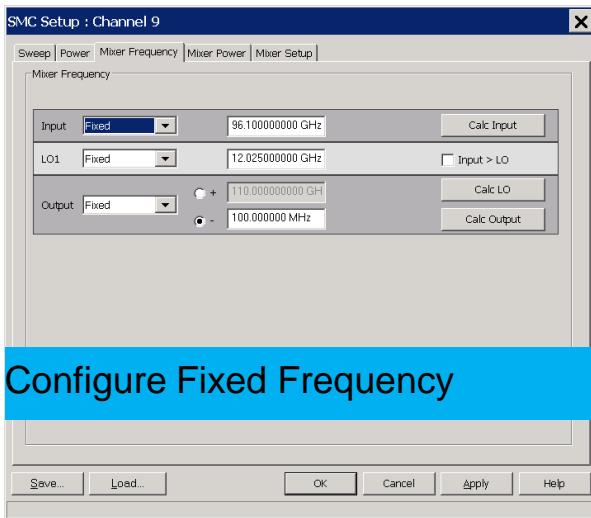


Agilent Technologies

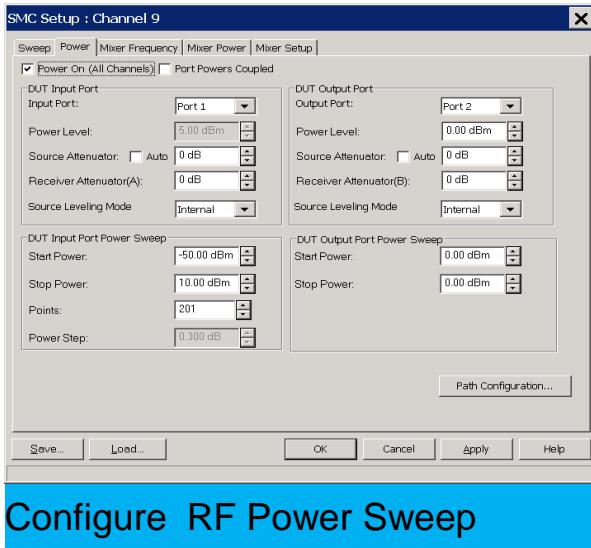
Adding Rx Conversion and S-Parameters



Adding Rx Power Sweep of Input Power



Configure Fixed Frequency

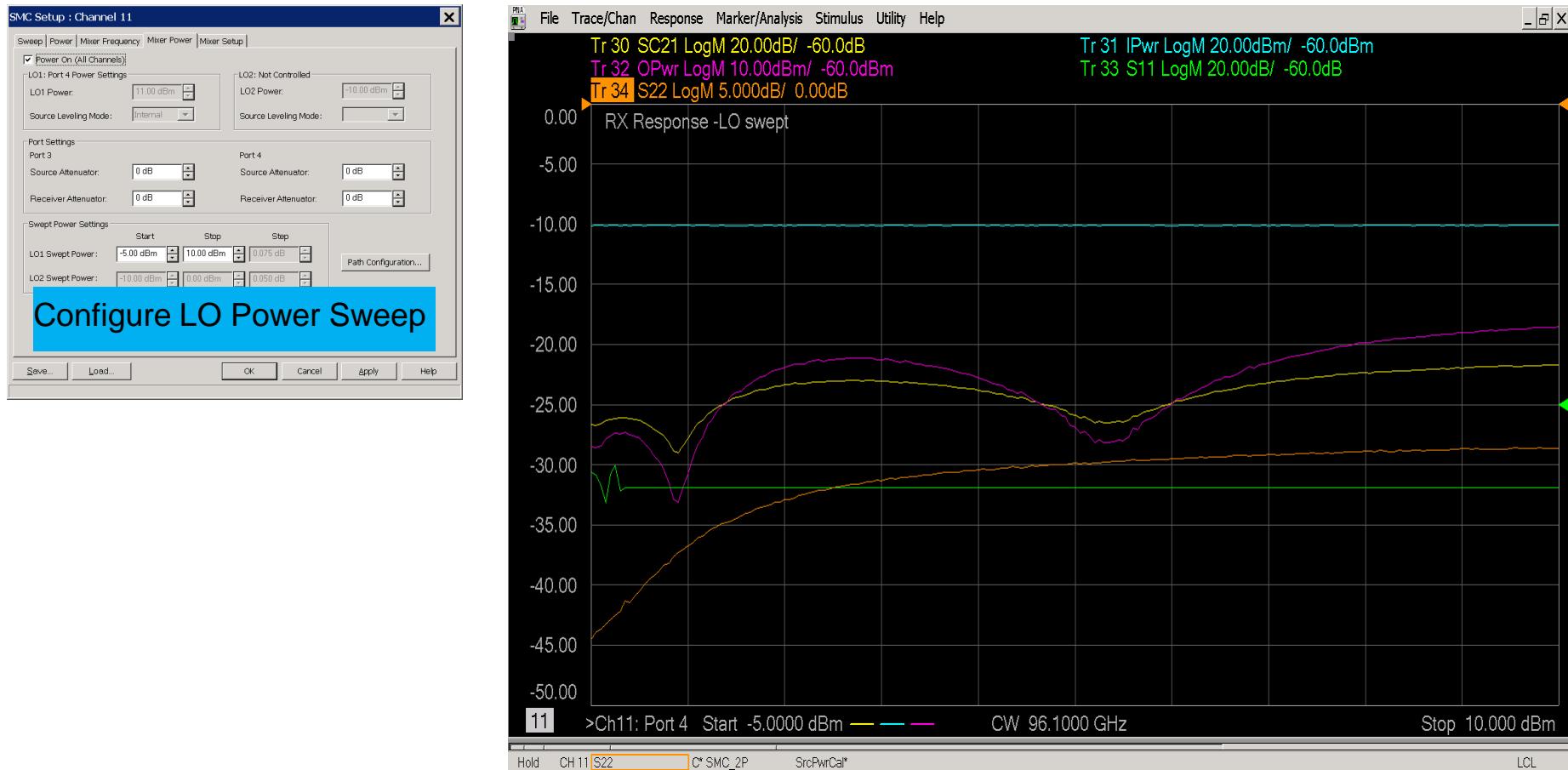


Configure RF Power Sweep



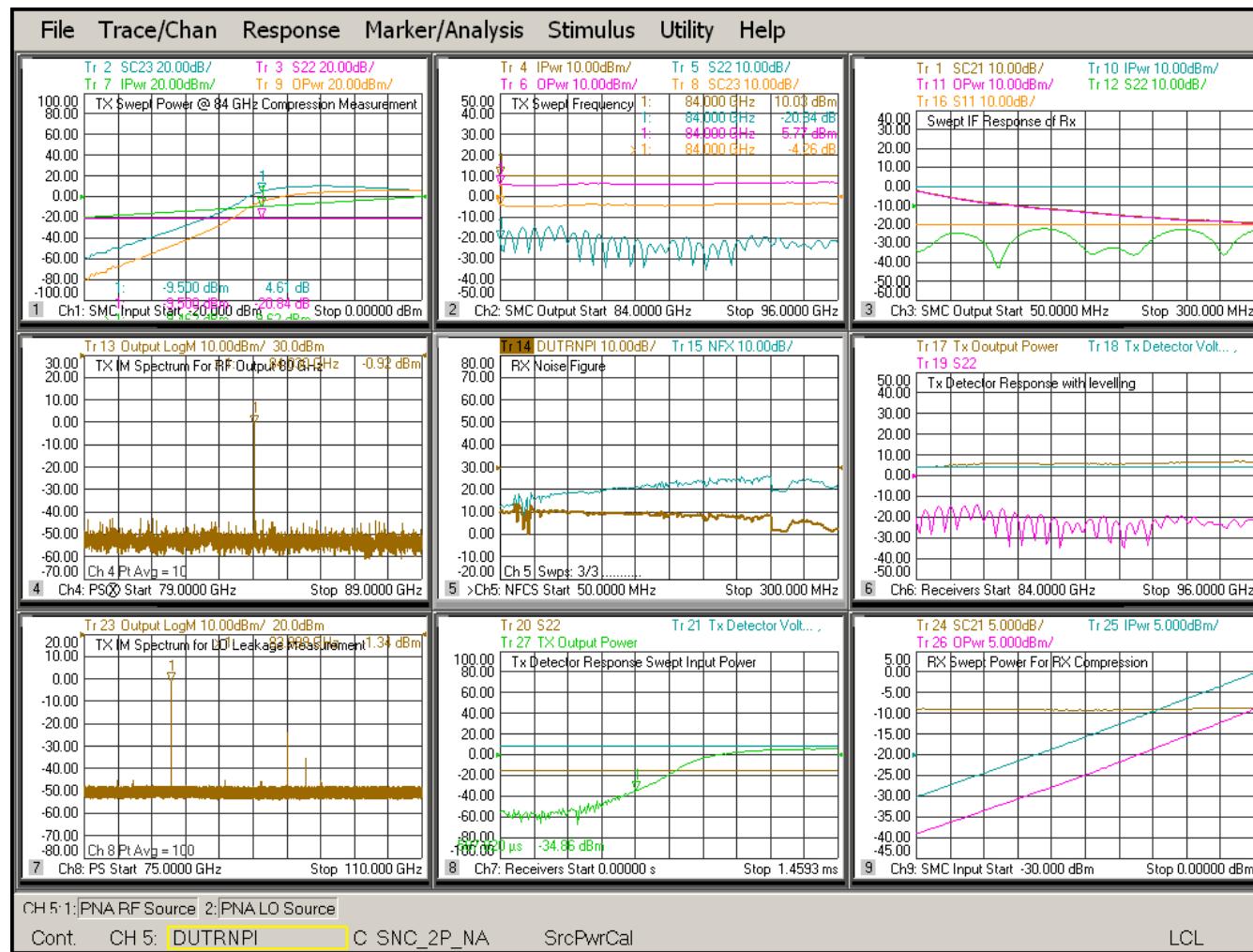
Agilent Technologies

Adding Rx Swept LO Response



Agilent Technologies

Summary SCMM of 60 GHz Tx / Rx components



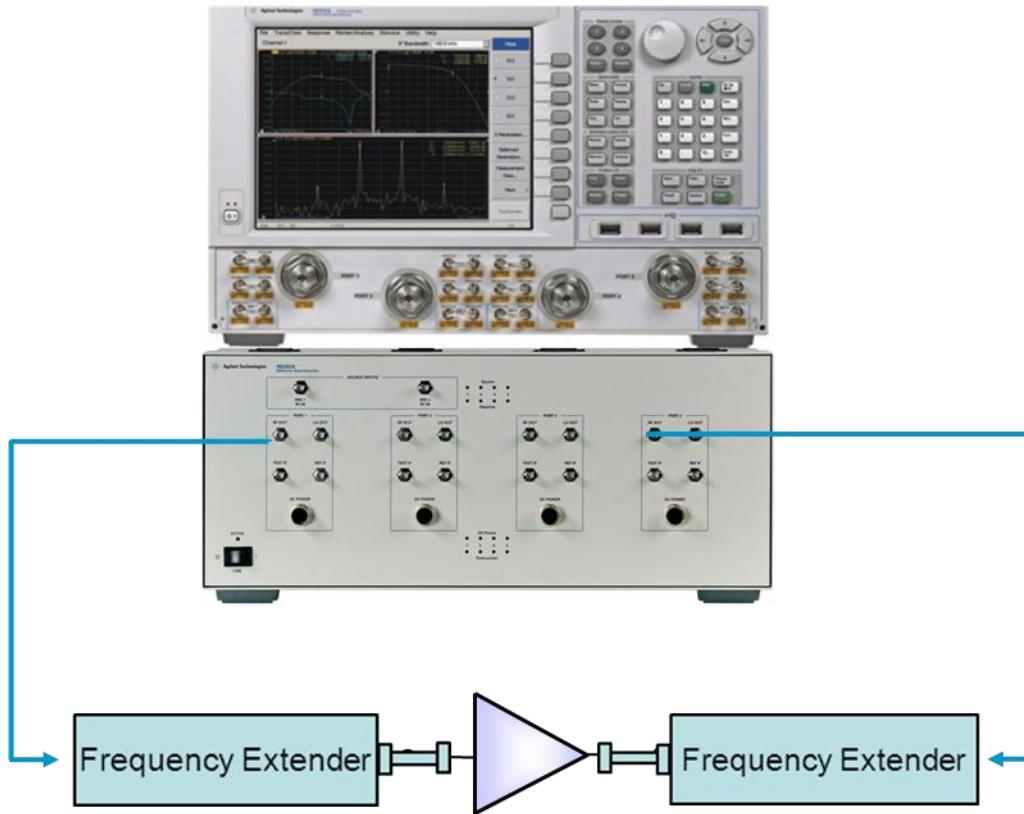
Agilent Technologies

Agilent Confidential

Agenda

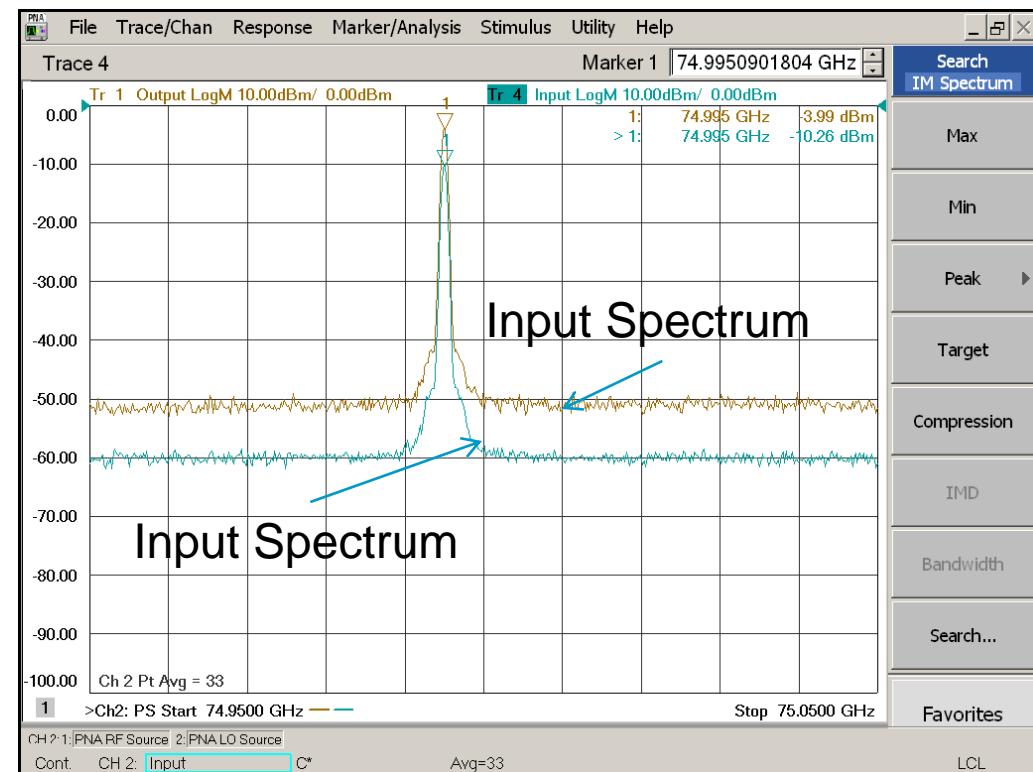
- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- Q&A

Measurement Setup



IM Spectrum: Measurement

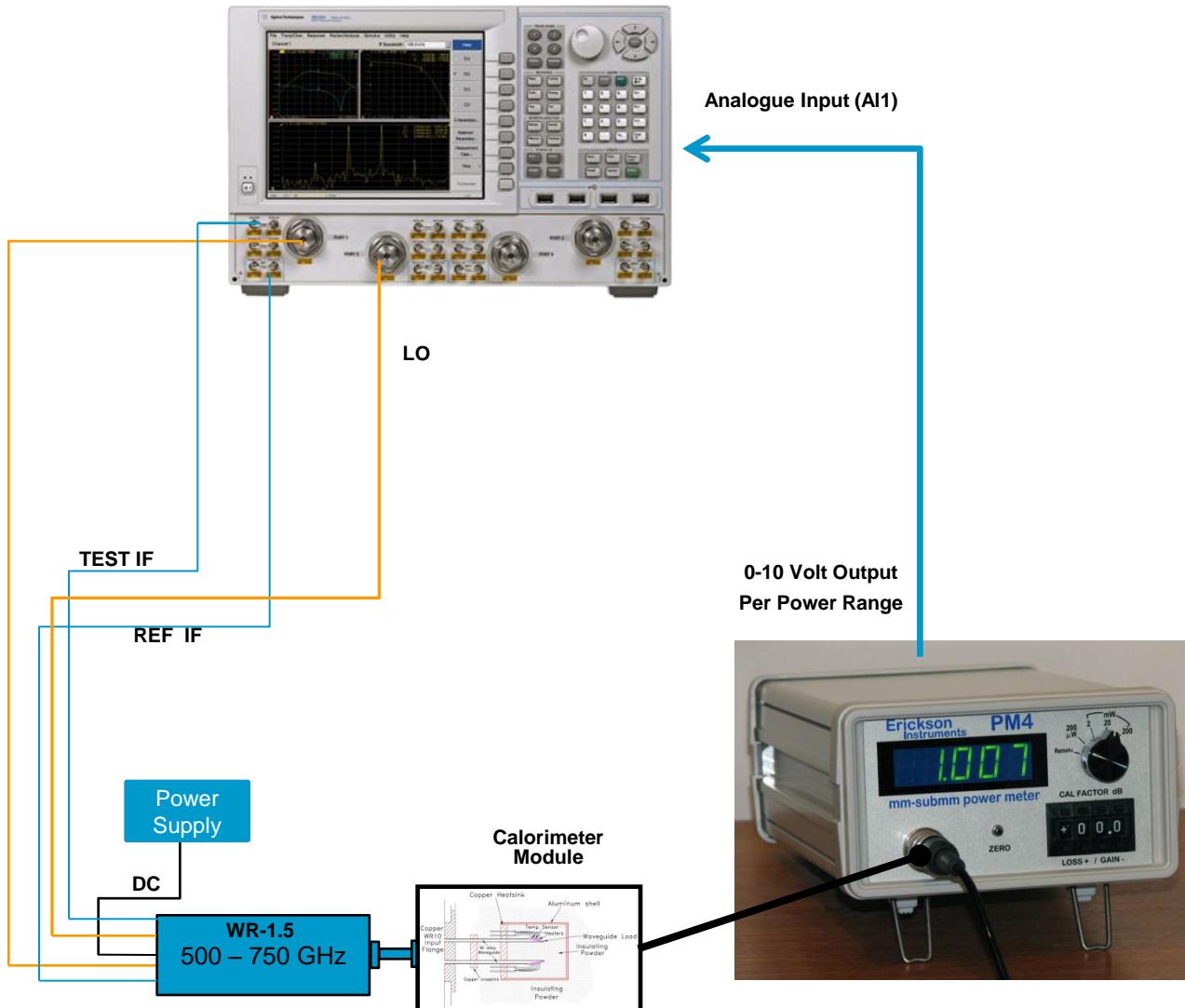
- Measurement Setup
 - Assign Measurement class
 - Set Path configuration to Thru path
 - Setup the port power to correct
- Stimulus
 - Set start and stop frequency
- Measure
 - Input and output Spectrum



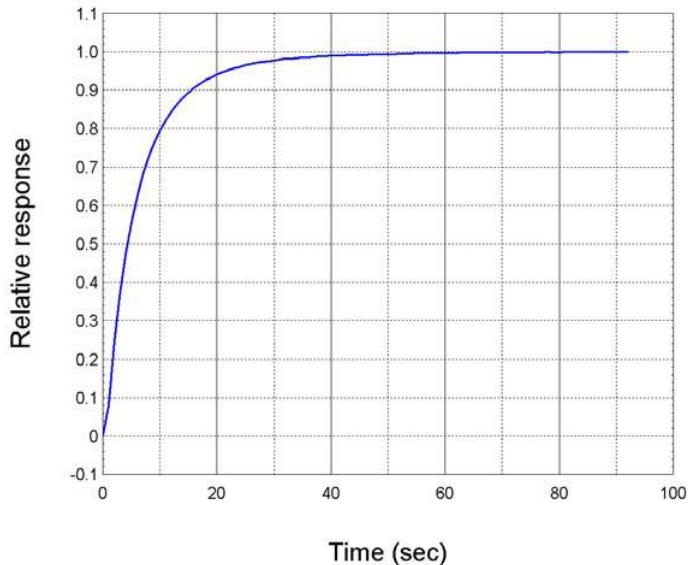
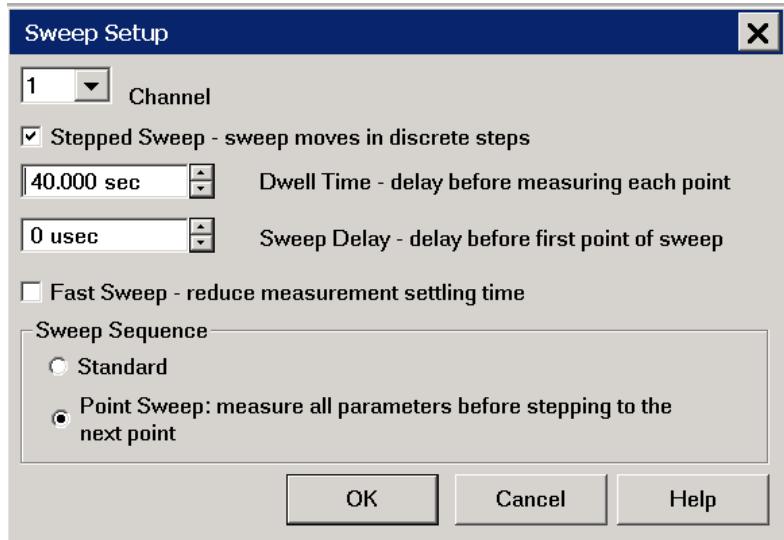
Agenda

- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - **THz Power Calibration**
 - Materials Measurements at THz
- Q&A

THz Power Calibration WR1.5 System Configuration



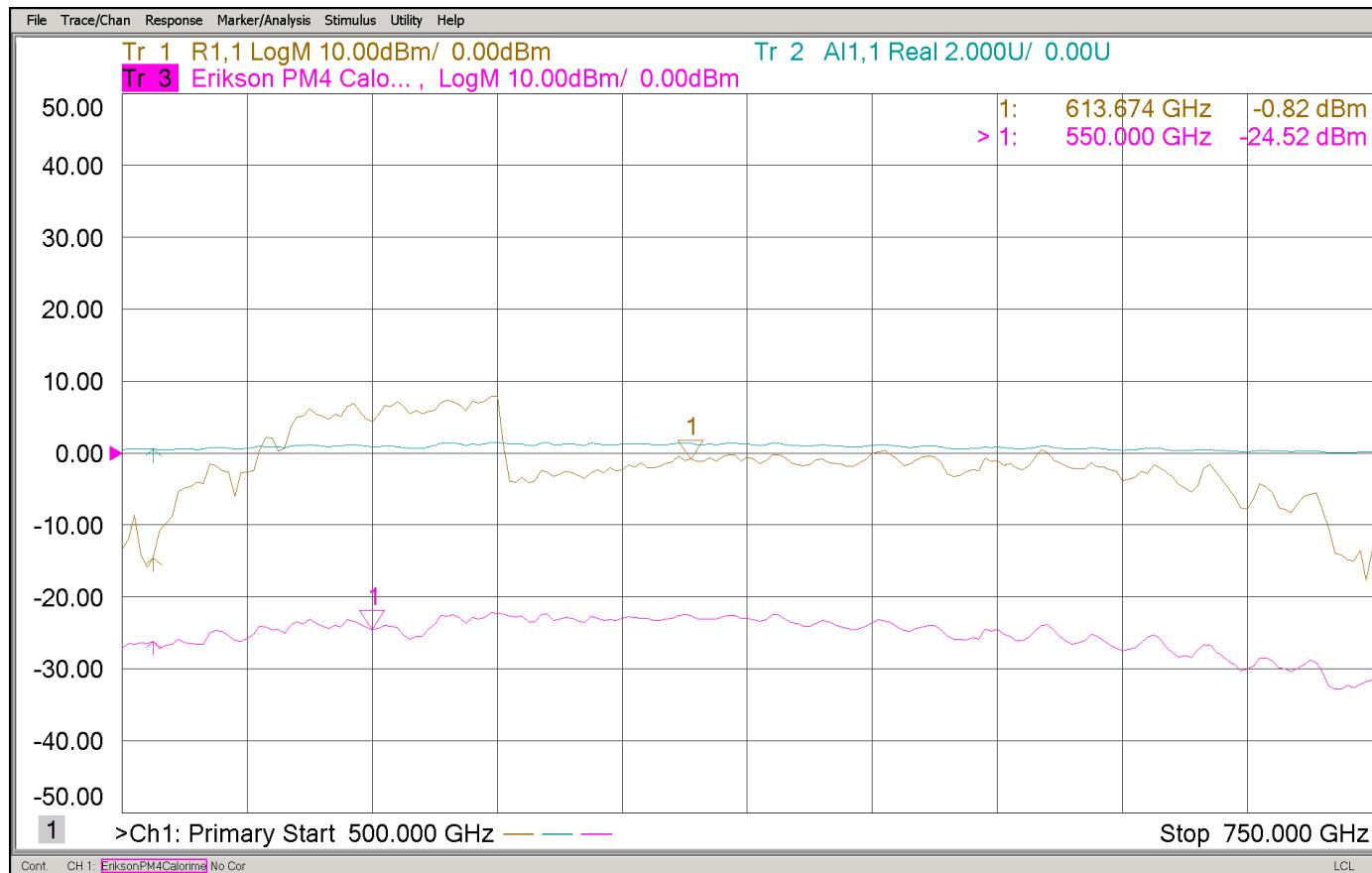
Sweep Setting – PM-4 200 µWatt Range



PM4 Port Power Characterization

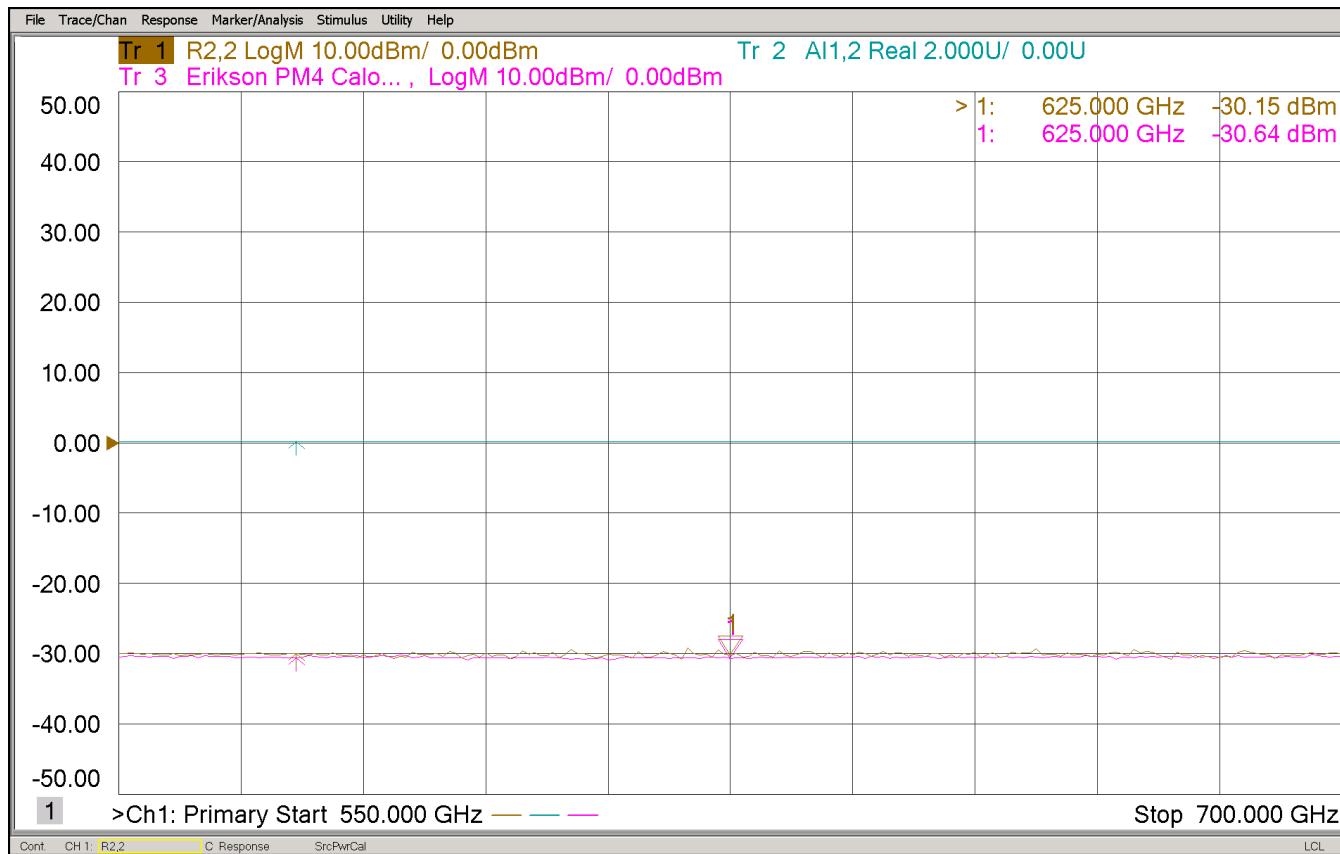
1. Measurement of power with the PM4 at these frequencies are very sensitive and require at least a 20 second settling time for a valid measurement
2. Configure the system to sweep the frequency range of interest as well as the number of points
3. In this example we use 500 GHz - 750 GHz with 201 point characterization, while it is not required for the source calibration it provides the full characterization
4. Turn off RF to the Frequency extender zero and calibrate the Calorimeter
5. Turn on the RF and save the measurement results as a file.

PM4 Port Power Characterization



- Note Trace 3 above is created by using the equation editor to convert the analog input AI1,1 into a power reading of dBm.
- In this example we do this by taking the displaying the ($\sqrt{Tr2/50}$), in which 50 is the 10V to 200 uWatt range
- Save Trace 3 above into a file and add the RF power setting used, in this example we used +3 dBm

Verification of calibration

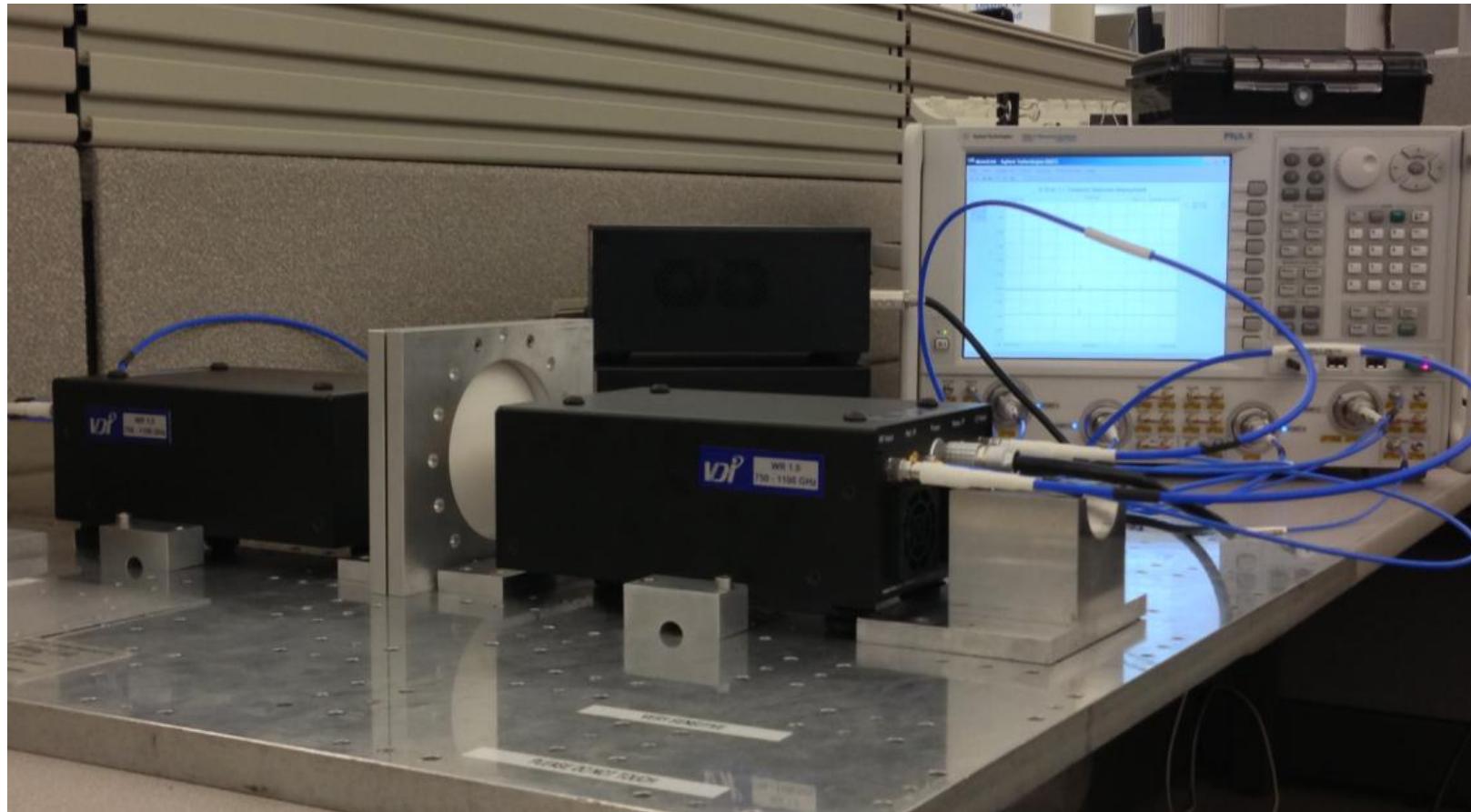


Measurement of port 2 source power as shown by the PNA-X receiver R2,2 in comparison to the actual measured PM4 power at port 2.

Agenda

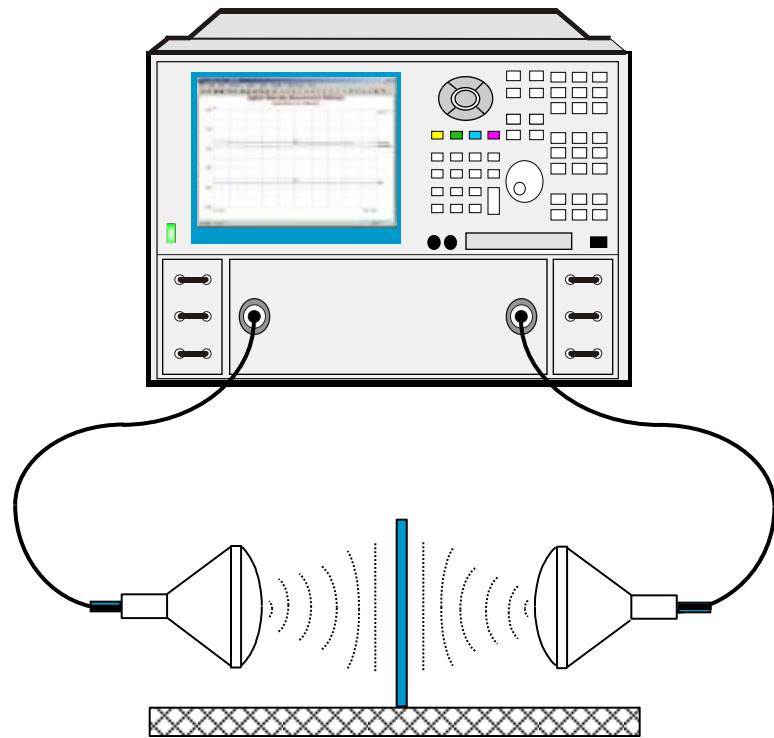
- Millimeter wave and THz applications
- Measurement Solution
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- Active Device Measurements
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- Q&A

THz Materials Measurement Solution



Agilent Technologies

Calibration is Required

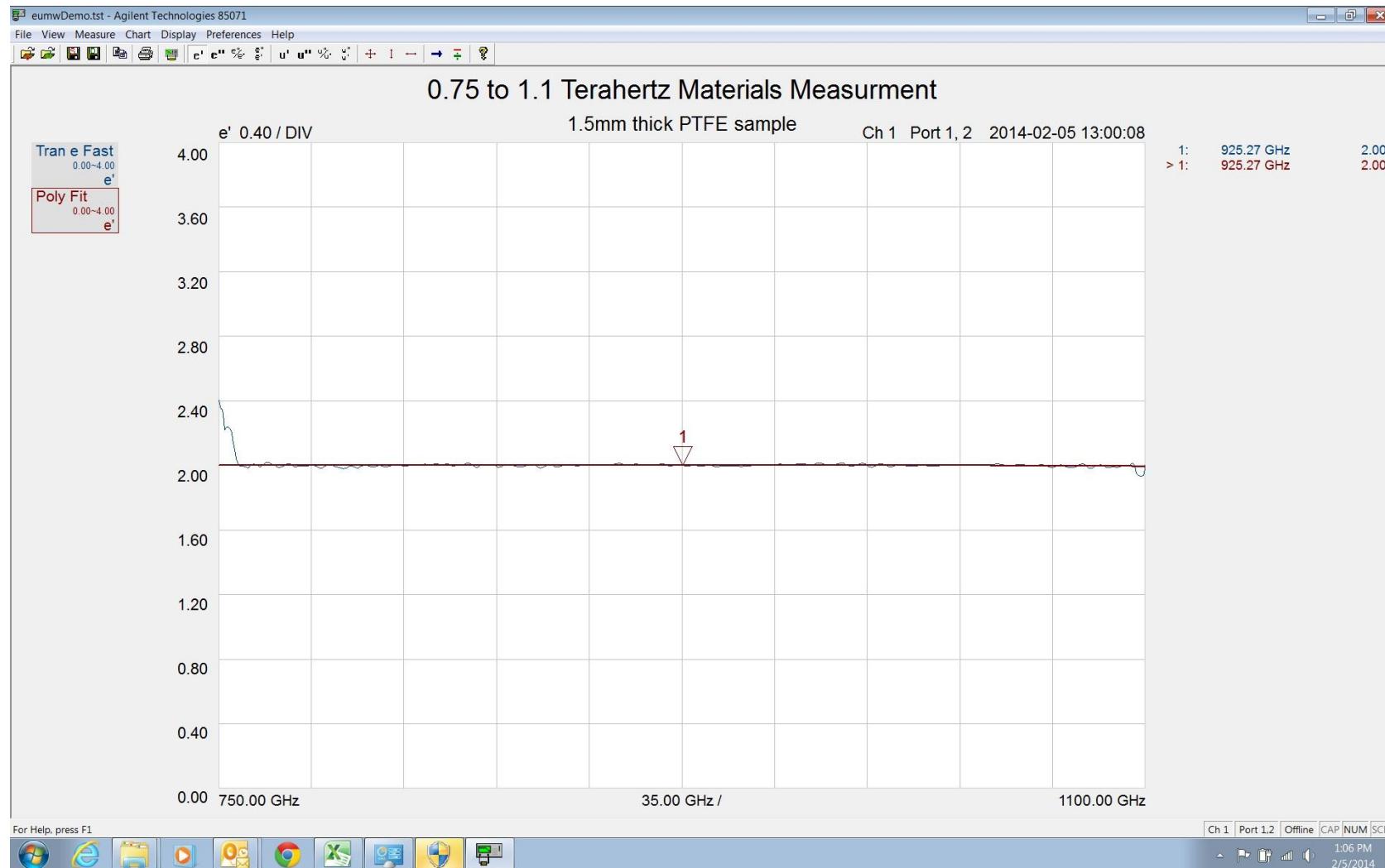


Before a measurement can be made, a calibration must be performed to remove systematic errors.



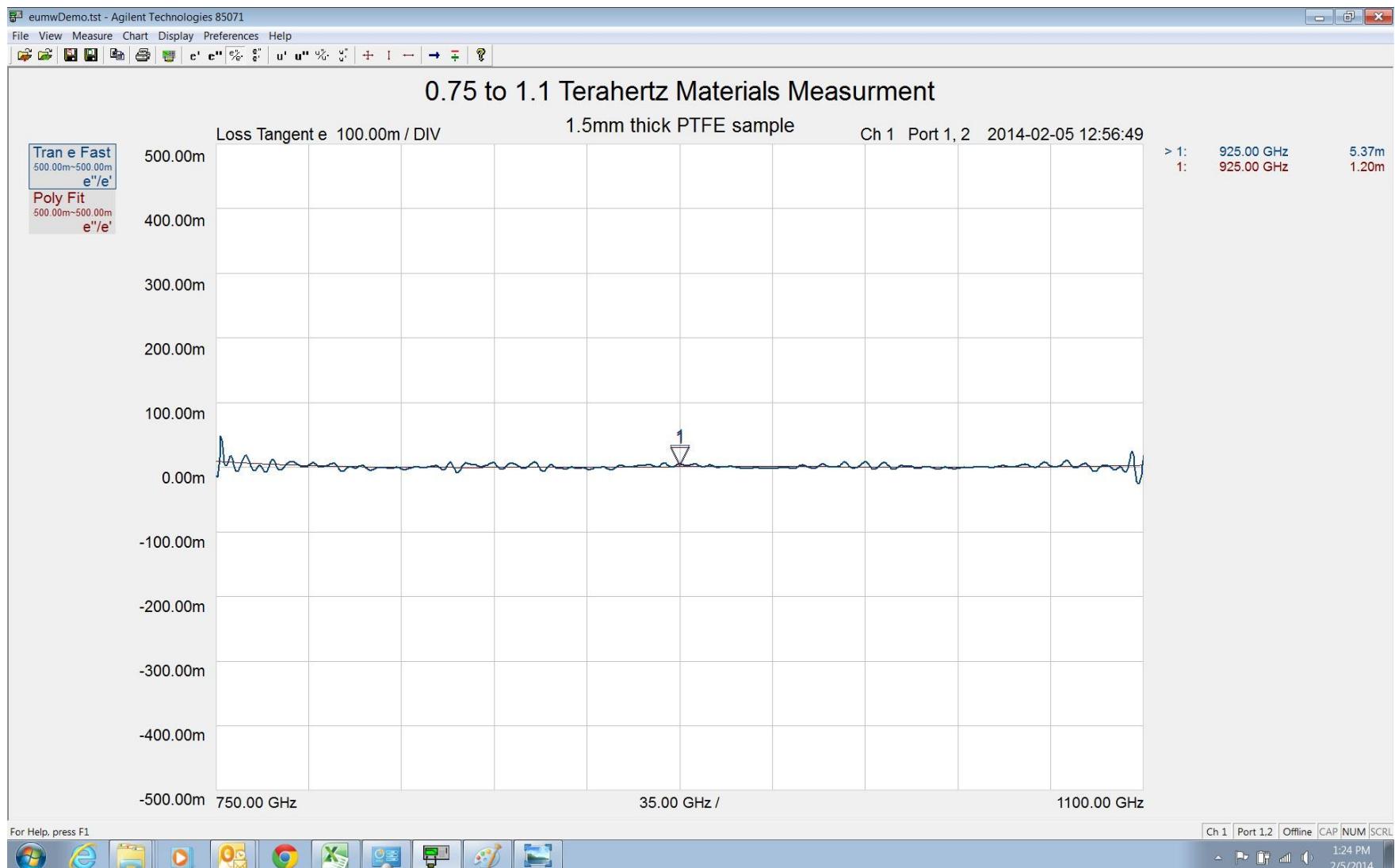
Agilent Technologies

THz Materials Measurements e' Real Part Permittivity



Agilent Technologies

THz Materials Measurements ϵ'/ϵ'' Tan Delta



Agilent Technologies

Agenda

- **Millimeter wave and THz applications**
- **Measurement Solution**
 - Basic system architecture
 - Capability Enabling Active Device Measurements
- **Active Device Measurements**
 - SCMM Broadband Amplifier Characterization
 - SCMM of 60 GHz Tx / Rx components
 - IMD Spectrum measurements
 - THz Power Calibration
 - Materials Measurements at THz
- **Q&A**

Thank You

